TEXAS INSTRUMENTS

PCM5100A, PCM5101A, PCM5102A
PCM5100A-Q1, PCM5101A-Q1, PCM5102A-Q1

SLAS859C – MAY 2012 – REVISED MAY 2015

PCM510xA 2.1 V_{RMS}, 112/106/100 dB Audio Stereo DAC with PLL and 32-bit, 384 kHz PCM Interface

1 Features

- Ultra Low Out-of-Band Noise
- Integrated High-Performance Audio PLL with BCK Reference to Generate SCK Internally
- Direct Line Level 2.1-V_{RMS} Output
- No DC Blocking Capacitors Required
- Line Level Output Down to 1KΩ
- Intelligent Muting System; Soft Up or Down Ramp and Analog Mute For 120-dB Mute SNR
- Accepts 16-, 24-, and 32-Bit Audio Data
- PCM Data Formats: I^2S, Left-Justified
- Automatic Power-Save Mode When LRCK And BCK Are Deactivated
- 1.8 V or 3.3 V Failsafe LVCMOS Digital Inputs
- Simple Configuration Using Hardware Pins
- Single-Supply Operation: 14
  - 3.3 V Analog, 1.8 V or 3.3 V Digital
- Qualified in Accordance with AEC-Q100

2 Applications

- A/V Receivers, DVD, BD Players
- Automotive Infotainment and Telematics
- HDTV Receivers
- Aftermarket Automotive Amplifiers

3 Description

The PCM510xA devices are a family of monolithic CMOS-integrated circuits that include a stereo digital-to-analog converter and additional support circuitry in a small TSSOP package. The PCM510xA devices use the latest generation of TI's advanced segment-DAC architecture to achieve excellent dynamic performance and improved tolerance to clock jitter.

Using Directpath™ charge-pump technology, the PCM510xA devices provide 2.1-V_{RMS} ground centered outputs, allowing designers to eliminate DC blocking capacitors on the output, as well as external muting circuits traditionally associated with single-supply line drivers.

The integrated line driver surpasses all other charge-pump based line drivers by supporting loads down to 1 kΩ per pin.

The integrated PLL on the device removes the requirement for a system clock (commonly known as master clock), allowing a 3-wire I^2S connection and reducing system EMI.

Intelligent clock error and PowerSense undervoltage protection utilizes a two-level mute system for pop-free performance.

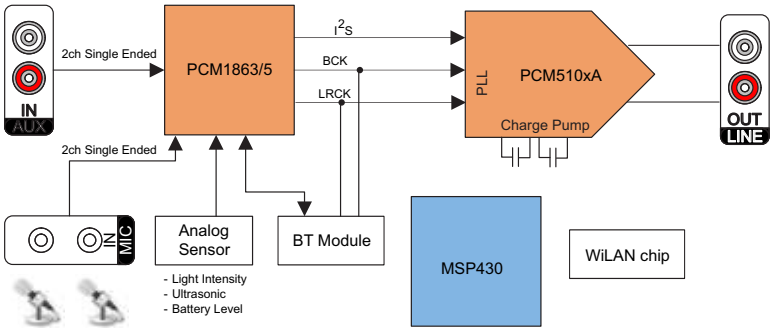
Compared with many conventional switched capacitor DAC architectures, the PCM510xA family offers up to 20 dB lower out-of-band noise, reducing EMI and aliasing in downstream amplifiers/ADCs, measured from the traditional 100-kHz OBN measurements to 3 MHz).

Table 1. Device Information(1)

PART NUMBER	PACKAGE	BODY SIZE (NOM)
PCM5102A	TSSOP (20)	5.50 mm × 4.40 mm
PCM5101A		
PCM5100A		

(1) For all available packages, see the orderable addendum at the end of the data sheet.

4 Simplified System Diagram



An IMPORTANT NOTICE at the end of this data sheet addresses availability, warranty, changes, use in safety-critical applications, intellectual property matters and other important disclaimers. PRODUCTION DATA.

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5 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision B (January 2015) to Revision C — **Page**

- Changed the device number from "PCM510x" to "PCM510xA" in the *Simplified System Diagram* ... 1
- Changed typical performance table to reflect part differences accurately ... 4
- Changed "Storage temperatures, T_{stg}" to "Operating junction temperature range at –40°C to 130°C" ... 6
- Changed "Storage temperature (Q1 devices) –40°C to 125°C" to "Storage temperatures, T_{stg} –65°C to 150°C" ... 6
- Changed the stereo line output load resistance MIN value in the *Recommended Operating Conditions* from "2 kΩ" to "1 kΩ" ... 6
- Changed the operating junction temperature range in the *Recommended Operating Conditions* from "MIN = –25°C MAX = 85°C" to "MIN = –40°C MAX = 130°C" ... 6
- Added "Q1 Automotive grade devices..." and "Consumer grade (non-Q1) devices..." to the condition statement in the *Electrical Characteristics* ... 7
- Added "Q1 Automotive grade devices..." and "Consumer grade (non-Q1) devices..." to the condition statement in the *Typical Characteristics* graphs section. ... 12
- Changed "MCK" to "SCK" at the PLL Clock in the *Functional Block Diagram* ... 14
- Added label "Mute Circuit" and ground symbols to pins DEMP and FMT in Figure 33 ... 26

Changes from Revision A (September 2012) to Revision B — **Page**

- Added *ESD Rating* table, *Detailed Description* section, *Application and Implementation* section, *Power Supply Recommendations* section, *Device and Documentation Support* section, and *Mechanical, Packaging, and Orderable Information* ... 1
- Added items to show 1.8 V DVDD capability ... 1
- Changed the *Features* list. ... 1
- Changed "Operating temperature range " to "Operating junction temperature range" ... 6
- Deleted redundant PLL specification in the *Recommended Operating Conditions* ... 6
- Deleted "Intelligent clock error..." and "...for pop-free performance." ... 14

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- Clarified clock generation explanation 24
- Clarified external SCK discussion. 25
- Deleted "The PCM510xA disables the internal PLL when an external SCK is supplied." 25

Changes from Original (May 2012) to Revision A **Page**

- Changed layout of first two pages 1
- Changed "VOUT = –1 dB" to "THD+N at –1 dBFS" in in the *Dymamic Performance* section of the *Electrical Characteristics* 8
- Changed reference to correct footnote 10
- Changed t_{SCKH} and t_{SCKL} values to 9ns 11
- Removed 48kHz sample rate with PLL-generated clock 25

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6 Device Comparison

Differences Between PCM510xA Devices

PART NUMBER	DYNAMIC RANGE	SNR	THD
PCM5102A	112dB	112dB	–93 dB
PCM5101A	106 dB	106 dB	–92 dB
PCM5100A	100 dB	100 dB	–90 dB

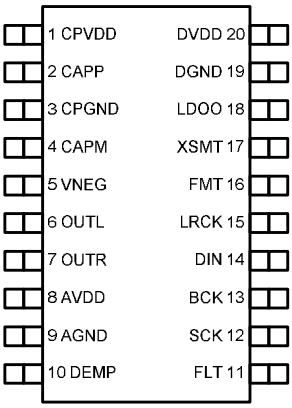
Typical Performance (3.3 V Power Supply)

PARAMETER	PCM5102 / PCM5101 / PCM5100
SNR	112 / 106 / 100 dB
Dynamic range	112 /106 / 100 dB
THD+N at –1 dBFS	–93/ –92 / –90 dB
Full-scale single-ended output	2.1 V_{RMS} (GND center)
Normal 8× oversampling digital filter latency	$20t_S$
Low latency 8× oversampling digital filter latency	$3.5t_S$
Sampling frequency	8 kHz to 384 kHz
System clock multiples (f_{SCK}): 64, 128, 192, 256, 384, 512, 768, 1024, 1152, 1536, 2048, 3072	Up to 50 MHz

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7 Pin Configuration and Functions

PW 20-Pin Package
(Top View)



Pin Functions

PIN		TYPE	DESCRIPTION
NAME	NO.		
AGND	9	—	Analog ground
AVDD	8	P	Analog power supply, 3.3 V
BCK	13	I	Audio data bit clock input(1)
CAPM	4	O	Charge pump flying capacitor terminal for negative rail
CAPP	2	O	Charge pump flying capacitor terminal for positive rail
CPGND	3	—	Charge pump ground
CPVDD	1	P	Charge pump power supply, 3.3 V
DEMP	10	I	De-emphasis control for 44.1-kHz sampling rate(1): Off (Low) / On (High)
DGND	19	—	Digital ground
DIN	14	I	Audio data input(1)
DVDD	20	P	Digital power supply, 1.8 V or 3.3 V
FLT	11	I	Filter select : Normal latency (Low) / Low latency (High)
FMT	16	I	Audio format selection : I^2S (Low) / Left-justified (High)
LDOO	18	P	Internal logic supply rail terminal for decoupling, or external 1.8 V supply terminal
LRCK	15	I	Audio data word clock input(1)
OUTL	6	O	Analog output from DAC left channel
OUTR	7	O	Analog output from DAC right channel
SCK	12	I	System clock input(1)
VNEG	5	O	Negative charge pump rail terminal for decoupling, –3.3 V
XSMT	17	I	Soft mute control(1): Soft mute (Low) / soft un-mute (High)

(1) Failsafe LVCMOS Schmitt trigger input

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8 Specifications

8.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)

		MIN	MAX	UNIT
Supply voltage	AVDD, CPVDD, DVDD	–0.3	3.9	V
	LDO with DVDD at 1.8 V	–0.3	2.25	
Digital input voltage	DVDD at 1.8 V	–0.3	2.25	
	DVDD at 3.3 V	–0.3	3.9	
Analog input voltage		–0.3	3.9	
Operating junction temperature range		–40	130	°C
Storage temperature, T_{stg}		–65	150	°C

8.2 ESD Ratings

		VALUE	UNIT
$V_{(ESD)}$ Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 (1)	±2000	V
	Charged-device model (CDM), per JEDEC specification JESD22-C101 (2)	±750	

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

8.3 Recommended Operating Conditions

				MIN	NOM	MAX	UNIT
AVDD	Analog power supply voltage range	Referenced to AGND (1)	VCOM mode	3	3.3	3.46	V
			VREF mode	3.2	3.3	3.46	
DVDD	Digital power supply voltage range	Referenced to DGND (1)	1.8 V DVDD	1.65	1.8	1.95	V
			3.3 V DVDD	3.1	3.3	3.46	
CPVDD	Charge pump supply voltage range	Referenced to CPGND (1)		3.1	3.3	3.46	V
MCLK	Master clock frequency					50	MHz
LOL, LOR	Stereo line output load resistance			1	10		kΩ
C_{LOUT}	Digital output load capacitance				10		pF
T_J	Operating junction temperature range			–40		130	°C

(1) All grounds on board are tied together; they must not differ in voltage by more than 0.2 V max, for any combination of ground signals.

8.4 Thermal Information

THERMAL METRIC (1)		PW	UNIT
		20 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	91.2	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	25.3	
$R_{\theta JB}$	Junction-to-board thermal resistance	42	
ψ_{JT}	Junction-to-top characterization parameter	1	
ψ_{JB}	Junction-to-board characterization parameter	41.5	
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	—	

(1) For more information about traditional and new thermal metrics, see the *IC Package Thermal Metrics* application report, SPRA953.

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8.5 Electrical Characteristics

Q1 Automotive grade devices are specified for T_A = –40°C to 125°C. Consumer grade (non-Q1) devices are specified at T_A = 25°C. All devices in the family are characterized with AVDD = CPVDD = DVD = 3.3 V, f_S = 48 kHz, system clock = 512 f_S and 24-bit data unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
	Resolution		16	24	32	Bits
Data Format (PCM Mode)						
	Audio data bit length		16	24	32	Bits
f_S (1)	Sampling frequency		8		384	kHz
f_{SCK}	System clock frequency	Clock multiples: 64, 128, 192, 256, 384, 512, 768, 1024, 1152, 1536, 2048, or 3072			50	MHz
Digital Input/Output for non-Q1 Consumer Grade Devices						
	Logic family: 3.3 V LVCMOS compatible					
V_{IH}	Input logic level		0.7×DV_{DD}			V
V_{IL}					0.3×DV_{DD}	
I_{IH}	Input logic current	V_{IN} = V_{DD}			10	µA
I_{IL}		V_{IN} = 0 V			–10	
V_{OH}	Output logic level	I_{OH} = –4 mA	0.8×DV_{DD}			V
V_{OL}		I_{OL} = 4 mA			0.22×DV_{DD}	
	Logic family 1.8 V LVCMOS compatible					
V_{IH}	Input logic level		0.7×DV_{DD}			V
V_{IL}					0.3×DV_{DD}	
I_{IH}	Input logic current	V_{IN} = V_{DD}			10	µA
I_{IL}		V_{IN} = 0 V			–10	
V_{OH}	Output logic level	I_{OH} = –2 mA	0.8×DV_{DD}			V
V_{OL}		I_{OL} = 2 mA			0.22×DV_{DD}	
Digital Input/Output for Q1 Automotive Grade Devices						
	Logic family: 3.3 V LVCMOS compatible					
V_{IH}	Input logic level		0.7×DV_{DD}			V
V_{IL}					0.3×DV_{DD}	
I_{IH}	Input logic current	V_{IN} = V_{DD}			10	µA
I_{IL}		V_{IN} = 0 V			–10	
V_{OH}	Output logic level	I_{OH} = –4 mA	0.8×DV_{DD}			V
V_{OL}		I_{OL} = 4 mA			0.22×DV_{DD}	
	Logic family 1.8 V LVCMOS compatible					
V_{IH}	Input logic level		0.7×DV_{DD}			V
V_{IL}					0.3×DV_{DD}	
I_{IH}	Input logic current	V_{IN} = V_{DD}			10	µA
I_{IL}		V_{IN} = 0 V			–10	
V_{OH}	Output logic level	I_{OH} = –2 mA	0.8×DV_{DD}			V
V_{OL}		I_{OL} = 2 mA			0.3×DV_{DD}	

(1) One sample time is defined as the reciprocal of the sampling frequency. $1t_S = 1/f_S$

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Electrical Characteristics (continued)

Q1 Automotive grade devices are specified for T_A = –40°C to 125°C. Consumer grade (non-Q1) devices are specified at T_A = 25°C. All devices in the family are characterized with AVDD = CPVDD = DVD = 3.3 V, f_S = 48 kHz, system clock = 512 f_S and 24-bit data unless otherwise noted.

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
Dynamic Performance (PCM Mode)(2)(3)							
	THD+N at –1 dBFS(3)	f_S = 48 kHz	PCM5102A		–93	–83	dB
			PCM5101A		–92	–82	
			PCM5100A		–90	–80	
		f_S = 96 kHz and 192 kHz	PCM5102A		–93		
			PCM5101A		–92		
			PCM5100A		–90		
	Dynamic range(3)	EIAJ, A-weighted, f_S = 48 kHz	PCM5102A	106	112		
			PCM5101A	100	106		
			PCM5100A	95	100		
		EIAJ, A-weighted, f_S = 96 kHz and 192 kHz	PCM5102A		112		
			PCM5101A		106		
			PCM5100A		100		
	Signal-to-noise ratio(3)	EIAJ, A-weighted, f_S = 48 kHz	PCM5102A		112		
			PCM5101A		106		
			PCM5100A		100		
		EIAJ, A-weighted, f_S = 96 kHz and 192 kHz	PCM5102A		112		
			PCM5101A		106		
			PCM5100A		100		
	Signal to noise ratio with analog mute(3)(4)	EIAJ, A-weighted, f_S = 48 kHz		113	123		
		EIAJ, A-weighted, f_S = 96 kHz and 192 kHz			123		
	Channel separation	f_S = 48 kHz	PCM5102A	100	109		
			PCM5101A	95	103		
			PCM5100A	90	97		
		f_S = 96 kHz	PCM5102A		109		
			PCM5101A		103		
			PCM5100A		97		
		f_S = 192 kHz	PCM5102A		109		
			PCM5101A		103		
			PCM5100A		97		

(2) Filter condition: THD+N: 20-Hz HPF, 20-kHz AES17 LPF; Dynamic range: 20-Hz HPF, 20-kHz AES17 LPF; A-weighted signal-to-noise ratio: 20-Hz HPF, 20-kHz AES17 LPF; A-weighted channel separation: 20-Hz HPF, 20-kHz AES17 LPF. Analog performance specifications are measured using the System Two Cascade™ audio measurement system by Audio Precision™ in the RMS mode.
(3) Output load is 10 kΩ, with 470-Ω output resistor and a 2.2-nF shunt capacitor (see recommended output filter).
(4) Assert XSMT or both L-ch and R-ch PCM data are Bipolar Zero.

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Electrical Characteristics (continued)

Q1 Automotive grade devices are specified for T_A = –40°C to 125°C. Consumer grade (non-Q1) devices are specified at T_A = 25°C. All devices in the family are characterized with AVDD = CPVDD = DVD = 3.3 V, f_S = 48 kHz, system clock = 512 f_S and 24-bit data unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
Analog Output						
	Output voltage			2.1		V_{RMS}
	Gain error		–6	±2	6	% of FSR
	Gain error on Q1 Automotive Grade Devices		–7	±2	7	% of FSR
	Gain mismatch, channel-to-channel		–6	±2	6	% of FSR
	Gain mismatch, channel-to-channel on Q1 Devices		–6	±2	6	% of FSR
	PCM5100/1 bipolar zero error	At bipolar zero	–5	±1	5	mV
	PCM5102 Bipolar zero error	At bipolar zero	–2	±1	2	mV
	Load impedance		1			kΩ
Filter Characteristics–1: Normal						
	Pass band				0.45f_S	
	Stop band		0.55f_S			
	Stop band attenuation		–60			dB
	Pass-band ripple				±0.02	
	Delay time			20t_S		s
Filter Characteristics–2: Low Latency						
	Pass band				0.47f_S	
	Stop band		0.55f_S			
	Stop band attenuation		–52			dB
	Pass-band ripple				±0.0001	
	Delay time			3.5t_S		s
Power Supply Requirements						
DV_{DD}	Digital supply voltage	Target DV_{DD} = 1.8 V	1.65	1.8	1.95	VDC
DV_{DD}	Digital supply voltage	Target DV_{DD} = 3.3 V	3	3.3	3.6	VDC
AV_{DD}	Analog supply voltage		3	3.3	3.6	
CPV_{DD}	Charge-pump supply voltage		3	3.3	3.6	
I_{DD}	DV_{DD} supply current at 1.8 V(5)	f_S = 48 kHz		7		mA
		f_S = 96 kHz		8		
		f_S = 192 kHz		9		
I_{DD}	DV_{DD} supply current at 1.8 V(6)	f_S = 48 kHz		7		mA
		f_S = 96 kHz		8		
		f_S = 192 kHz		9		
I_{DD}	DV_{DD} supply current at 1.8 V(7)	Standby		0.3		mA
I_{DD}	DV_{DD} supply current at 3.3 V(5)	f_S = 48 kHz		7	12	mA
		f_S = 96 kHz		8		
		f_S = 192 kHz		9		
I_{DD}	DV_{DD} supply current at 3.3 V(6)	f_S = 48 kHz		8	13	mA
		f_S = 96 kHz		9		
		f_S = 192 kHz		10		
I_{DD}	DV_{DD} supply current at 3.3 V(7)	Standby		0.5	0.8	mA
I_{DD}	AV_{DD} / CPV_{DD} supply current(5)	f_S = 48 kHz		11	16	mA
		f_S = 96 kHz		11		
		f_S = 192 kHz		11		

(5) Input is Bipolar Zero data.
(6) Input is 1 kHz –1 dBFS data.
(7) Power Down Mode

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Electrical Characteristics (continued)

Q1 Automotive grade devices are specified for T_A = –40°C to 125°C. Consumer grade (non-Q1) devices are specified at T_A = 25°C. All devices in the family are characterized with AVDD = CPVDD = DVD = 3.3 V, f_S = 48 kHz, system clock = 512 f_S and 24-bit data unless otherwise noted.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
I_{DD}	AV_{DD} / CPV_{DD} supply current(6)	f_S = 48 kHz		22	32	mA
		f_S = 96 kHz		22		
		f_S = 192 kHz		22		
I_{DD}	AV_{DD} / CPV_{DD} supply current(7)	f_S = n/a		0.2	0.4	mA
	Power dissipation, DV_{DD} = 1.8 V(5)	f_S = 48 kHz		49	185	mW
		f_S = 96 kHz		51		
		f_S = 192 kHz		53		
	Power dissipation, DV_{DD} = 1.8 V(6)	f_S = 48 kHz		85	187	mW
		f_S = 96 kHz		87		
		f_S = 192 kHz		89		
	Power dissipation, DV_{DD} = 1.8 V(7)	f_S = n/a (Power Down Mode)		1		mW
	Power dissipation, DV_{DD} = 3.3 V(5)	f_S = 48 kHz		60	92.4	mW
		f_S = 96 kHz		63		
		f_S = 192 kHz		66		
	Power dissipation, DV_{DD} = 3.3 V(6)	f_S = 48 kHz		99	148.5	mW
		f_S = 96 kHz		102		
		f_S = 192 kHz		106		
	Power dissipation, DV_{DD} = 3.3 V(7)	f_S = n/a (Power Down Mode)		2	4	mW

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8.6 Timing Requirements

Figure 1 shows the timing requirements for the system clock input. For optimal performance, use a clock source with low phase jitter and noise.

			MIN	TYP	MAX	UNIT
t_{SCY}	System clock pulse cycle time		20		1000	ns
t_{SCKH}	System clock pulse width, High	DVDD = 1.8 V	8			ns
		DVDD = 3.3 V	9			
t_{SCKL}	System clock pulse width, Low	DVDD = 1.8 V	8			ns
		DVDD = 3.3 V	9			

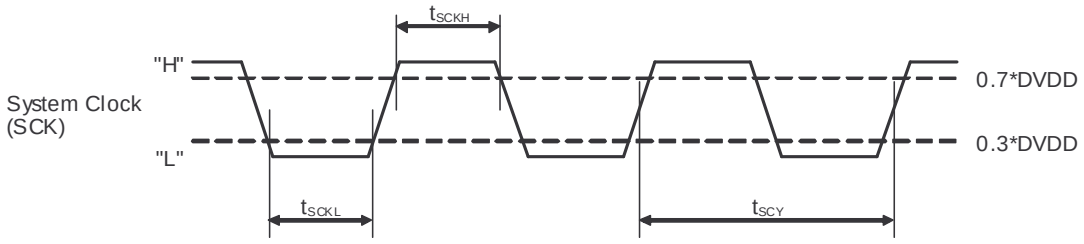


Figure 1. Timing Requirements for SCK Input

8.7 Timing Requirements, XSMT

		MIN	TYP	MAX	UNIT
t_r	Rise time			20	ns
t_f	Fall time			20	ns

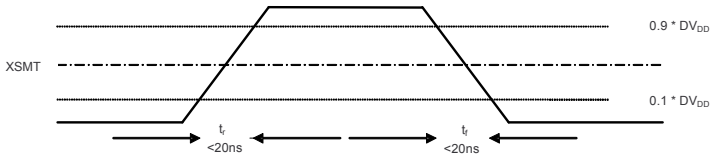


Figure 2. XSMT Timing for Soft Mute and Soft Un-Mute

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8.8 Typical Characteristics

Q1 Automotive grade devices are specified for T_A = –40°C to 125°C. Consumer grade (non-Q1) devices are specified at T_A = 25°C, AV_{DD} = CPV_{DD} = DV_{DD} = 3.3 V, f_S = 48 kHz, system clock = 512 f_S and 24-bit data unless otherwise noted.

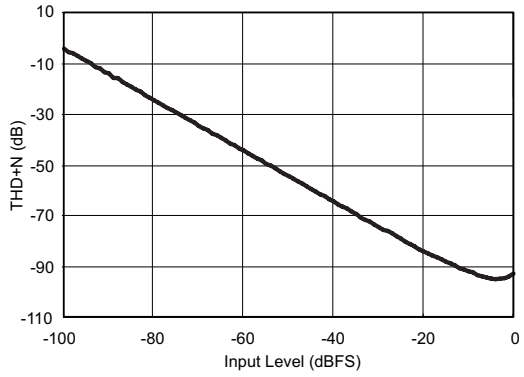


Figure 3. PCM5101 THD+N versus Input Level

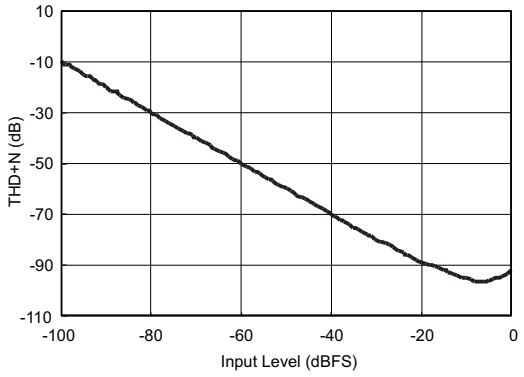


Figure 4. PCM5102 THD+N versus Input Level

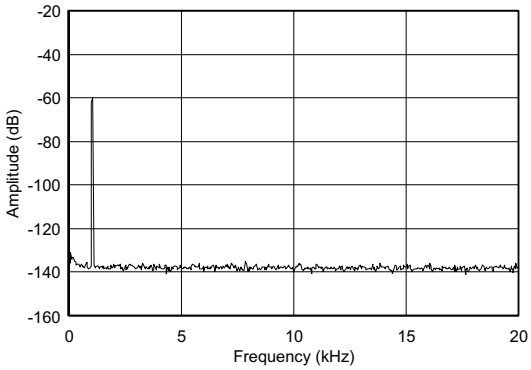


Figure 5. PCM5101 FFT Plot using a 1-kHz tone (–60dBFS) from DC to 20 kHz

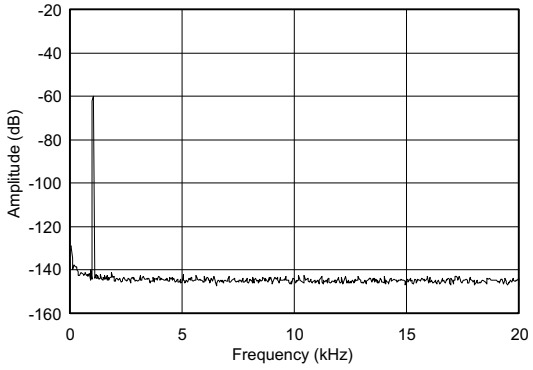


Figure 6. PCM5102 FFT Plot using a 1-kHz tone (–60dBFS) from DC to 20 kHz

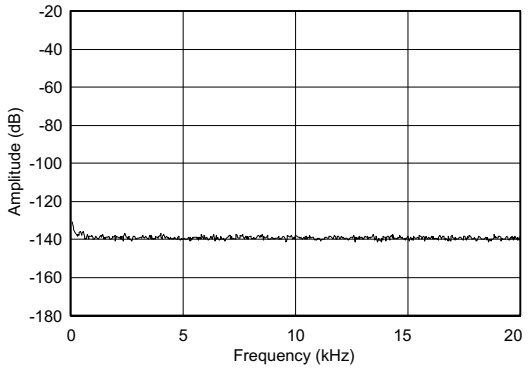


Figure 7. PCM5101 FFT Plot At Bipolar Zero Data (BPZ)

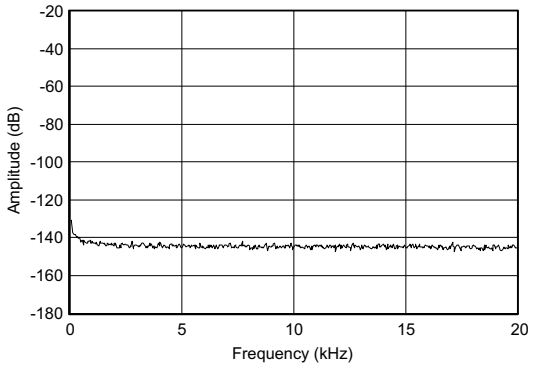


Figure 8. PCM5102 FFT Plot at BPZ

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Typical Characteristics (continued)

Q1 Automotive grade devices are specified for T_A = –40°C to 125°C. Consumer grade (non-Q1) devices are specified at T_A = 25°C, AV_{DD} = CPV_{DD} = DV_{DD} = 3.3 V, f_S = 48 kHz, system clock = 512 f_S and 24-bit data unless otherwise noted.

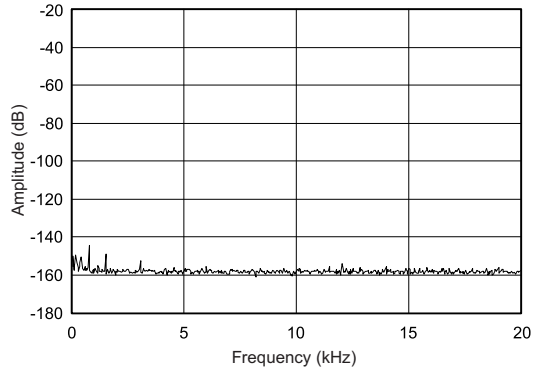


Figure 9. PCM5101 FFT Plot at BPZ With Analog Mute (AMUTE)

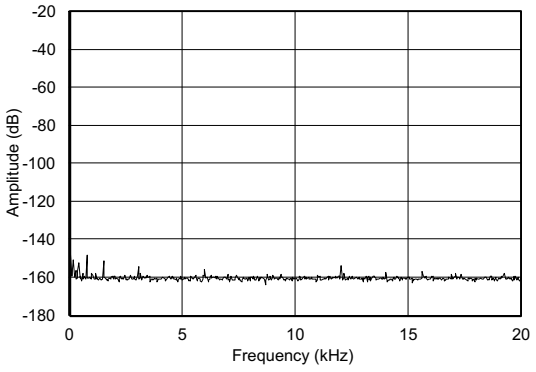


Figure 10. PCM5102 FFT Plot at BPZ With Analog Mute (AMUTE)

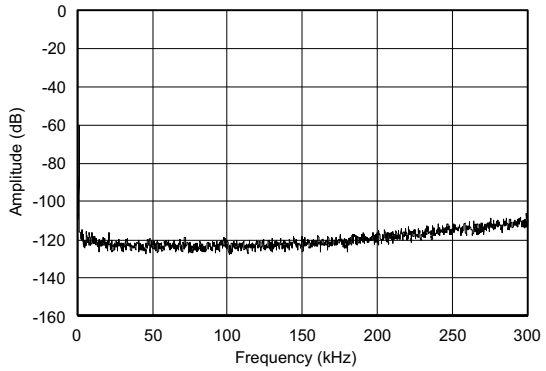


Figure 11. PCM5101 FFT Plot using a 1-kHz tone (–60dBFS) from DC to 300 kHz

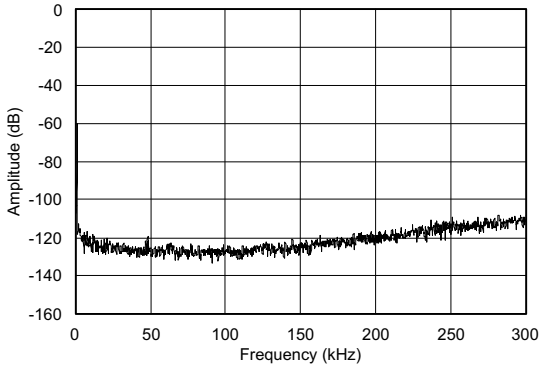


Figure 12. PCM5102 FFT Plot using a 1-kHz tone (–60dBFS) from DC to 300 kHz

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9 Detailed Description

9.1 Overview

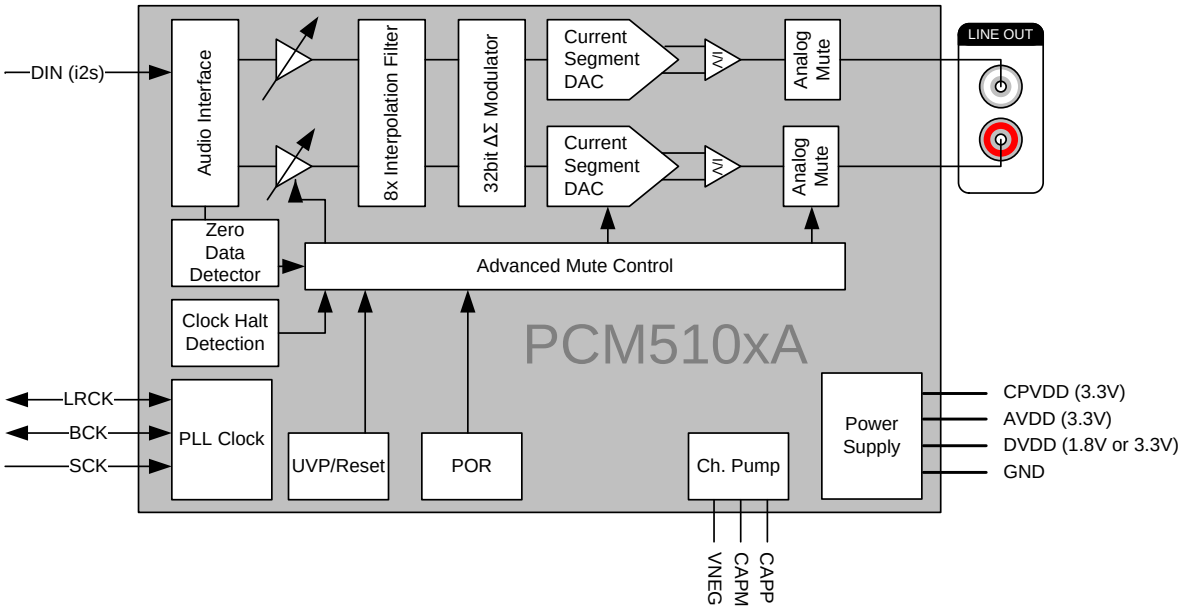
The integrated PLL on the device provided adds the flexibility to remove the system clock (commonly known as master clock), allowing a 3-wire I^2S connection and reducing system EMI.

Powersense undervoltage protection utilizes a two-level mute system. Upon clock error or system power failure, the device digitally attenuates the data (or last known good data) and then mutes the analog circuit.

Compared with existing DAC technology, the PCM510xA devices offer up to 20 dB lower out-of-band noise, reducing EMI and aliasing in downstream amplifiers/ADCs. (from traditional 100-kHz OBN measurements to 3 MHz).

The PCM510xA devices accept industry-standard audio data formats with 16- to 32-bit data. Sample rates up to 384 kHz are supported.

9.2 Functional Block Diagram



9.3 Feature Description

9.3.1 Terminology

Sampling frequency is symbolized by f_S. Full scale is symbolized by FS. Sample time as a unit is symbolized by t_S.

9.3.2 Audio Data Interface

9.3.2.1 Audio Serial Interface

The audio interface port is a 3-wire serial port with the signals LRCK, BCK, and DIN. BCK is the serial audio bit clock, used to clock the serial data present on DIN into the serial shift register of the audio interface. Serial data is clocked into the PCM510xA on the rising edge of BCK. LRCK is the serial audio left/right word clock. LRCK polarity for left/right is given by the format selected.

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Feature Description (continued)

Table 2. PCM510xA Audio Data Formats, Bit Depths and Clock Rates

CONTROL MODE	FORMAT	DATA BITS	MAX LRCK FREQUENCY [f_S]	SCK RATE [x f_S]	BCK RATE [x f_S]
Hardware Control	I^2S/LJ	32, 24, 20, 16	Up to 192 kHz	128 – 3072 (≤50MHz)	64, 48, 32
			384 kHz	64, 128	64, 48, 32

The PCM510xA requires the synchronization of LRCK and system clock, but does not need a specific phase relation between LRCK and system clock.

If the relationship between LRCK and system clock changes more than ±5 SCK, internal operation (using an onchip oscillator) is initialized within one sample period and analog outputs are forced to the bipolar zero level until resynchronization between LRCK and system clock is completed.

If the relationship between LRCK and BCK are invalid more than 4 LRCK periods, internal operation (using an onchip oscillator) is initialized within one sample period and analog outputs are forced to the bipolar zero level until resynchronization between LRCK and BCK is completed.

9.3.2.2 PCM Audio Data Formats

The PCM510xA supports industry-standard audio data formats, including standard I^2S and left-justified. Data formats are selected using the FMT (pin 16), Low for I^2S, and High for Left-justified. All formats require binary twos-complement, MSB-first audio data; up to 32-bit audio data is accepted.

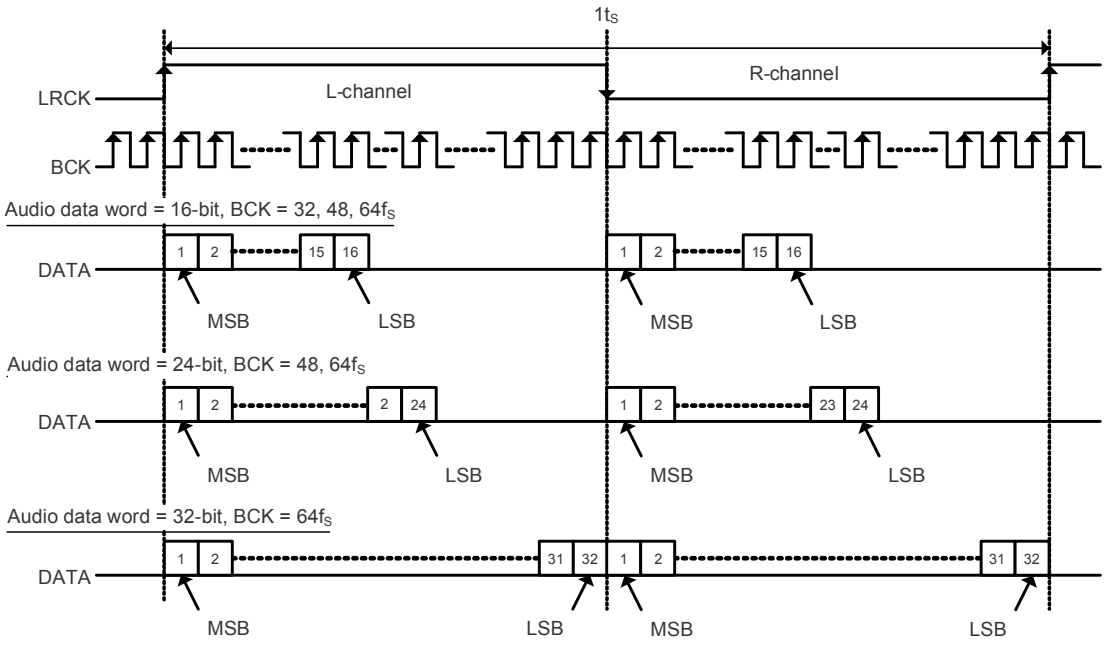
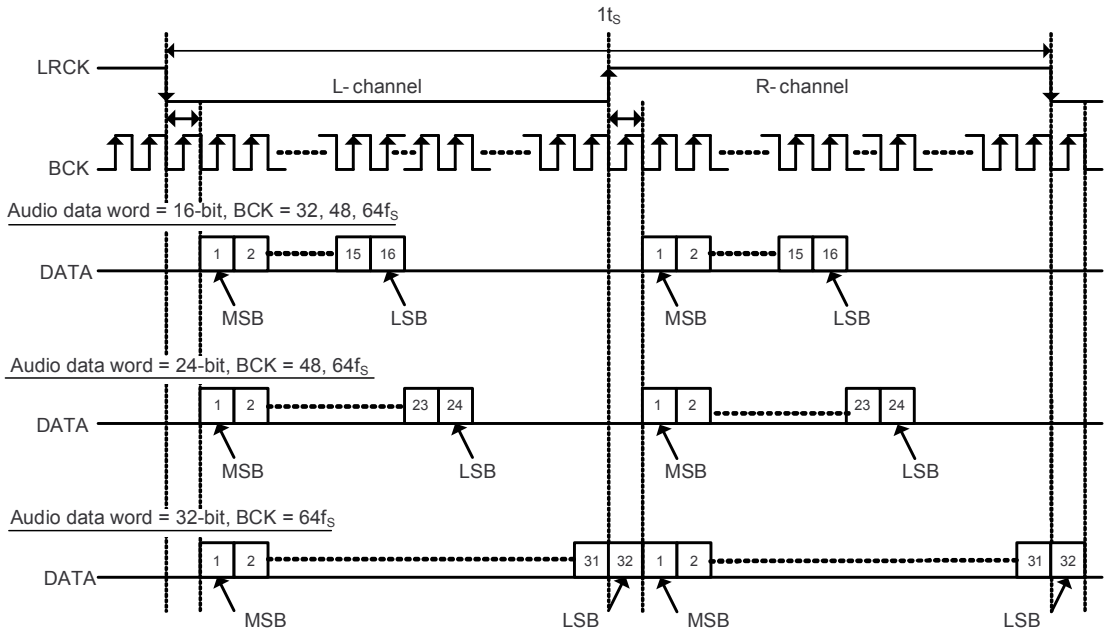


Figure 13. Left Justified Audio Data Format



I²S Data Format; L-channel = LOW, R-channel = HIGH

Figure 14. I²S Audio Data Format

9.3.2.3 Zero Data Detect

The PCM510xA has a zero-data detect function. When the device detects continuous zero data, it enters a full analog mute condition. The PCM510xA counts zero data over 1024 LRCKs (21ms @ 48kHz) before setting analog mute.

In Hardware mode, the device uses default values. By default, Both L-ch and R-ch have to be zero data for zero data detection to begin the muting process etc.

9.3.3 XSMT Pin (Soft Mute / Soft Un-Mute)

An external digital host controls the PCM510xA soft mute function by driving the XSMT pin with a specific minimum rise time (t_r) and fall time (t_f) for soft mute and soft un-mute. The PCM510xA requires t_r and t_f times of less than 20ns. In the majority of applications, this is no problem, however, traces with high capacitance may have issues.

When the XSMT pin is shifted from high to low (3.3 V to 0 V), a soft digital attenuation ramp begins. –1-dB attenuation is then applied every sample time from 0 dBFS to –∞. The soft attenuation ramp takes 104 samples.

When the XSMT pin is shifted from low to high (0 V to 3.3 V), a soft digital “un-mute” is started. 1-dB gain steps are applied every sample time from –∞ to 0 dBFS. The un-mute takes 104 samples.

In systems where XSMT is not required, it can be directly connected to AVDD.

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9.3.4 Audio Processing

9.3.4.1 Interpolation Filter

The PCM510xA provides two types of interpolation filter. Users can select which filter to use by using the FLT pin (pin 11).

Table 3. Digital Interpolation Filter Options

FLT Pin	Description
0	FIR normal x8/x4/x2/x1 interpolation filters
1	IIR low-latency x8/x4/x2/x1 interpolation filters

The normal x8 / x4 / x2 / x1(bypass) interpolation filter is programmed for sample rates from 8 kHz to 384 kHz.

Table 4. Normal x8 Interpolation Filter

Parameter	Condition	Value (Typ)	Value (Max)	Units
Filter gain pass band	0 ……. $0.45f_S$		±0.02	dB
Filter gain stop band	$0.55f_S$ ….. $7.455f_S$	–60		dB
Filter group delay		$22t_S$		s

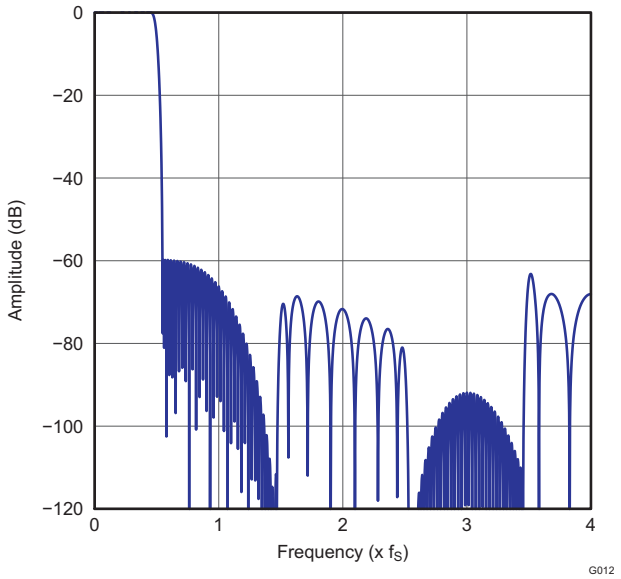


Figure 15. Normal x8 Interpolation Filter Frequency Response

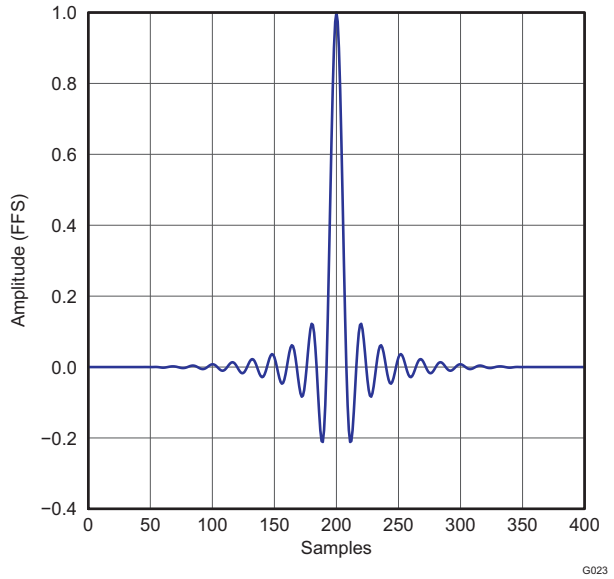


Figure 16. Normal x8 Interpolation Filter Impulse Response

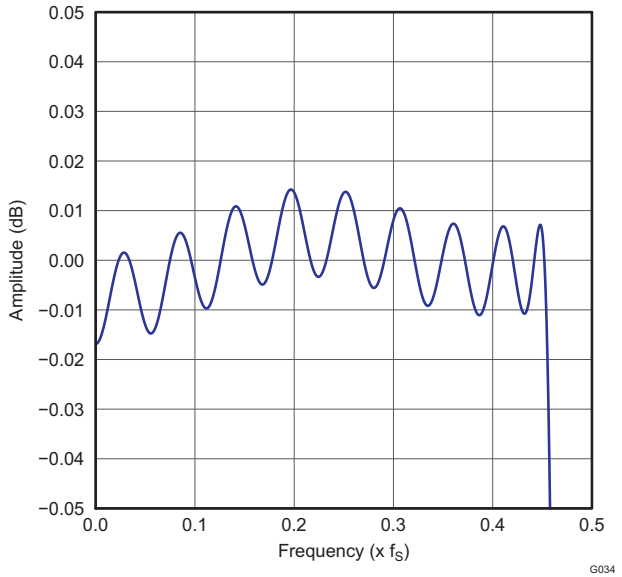


Figure 17. Normal x8 Interpolation Filter Passband Ripple

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The normal x4 / x2 / x1 (bypass) interpolation filter is programmed for sample rates from 8 kHz to 384 kHz.

Table 5. Normal x4 Interpolation Filter

Parameter	Condition	Value (Typ)	Value (Max)	Units
Filter gain pass band	0 ……. $0.45f_S$		±0.02	dB
Filter gain stop band	$0.55f_S$ ….. $7.455f_S$	–60		dB
Filter group delay		$22t_S$		s

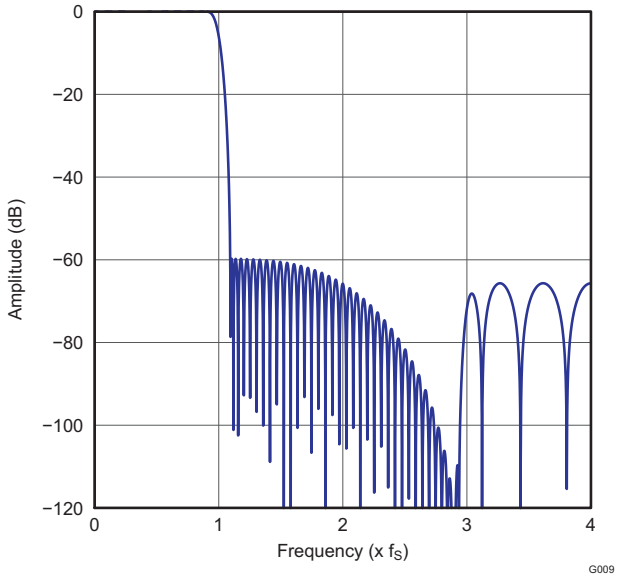


Figure 18. Normal x4 Interpolation Filter Frequency Response

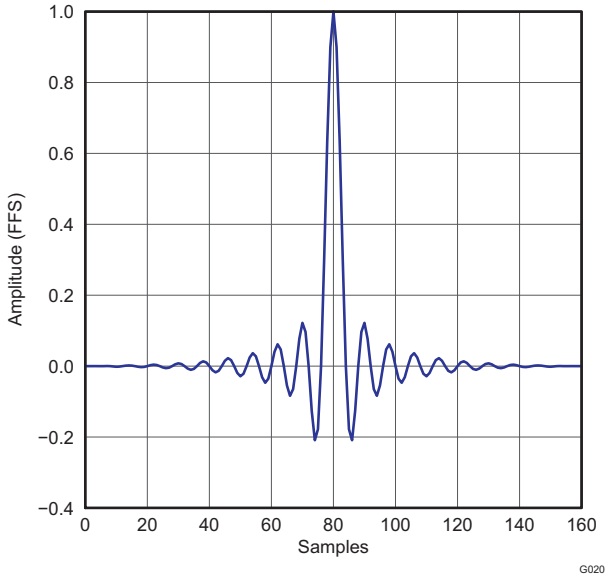


Figure 19. Normal x4 Interpolation Filter Impulse Response

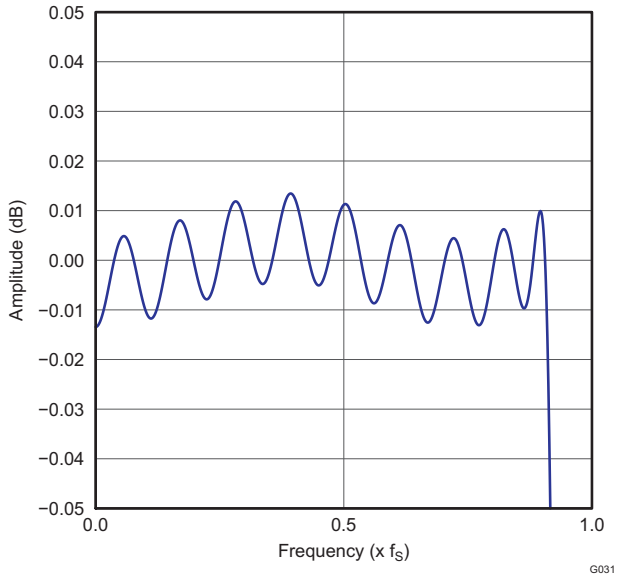


Figure 20. Normal x4 Interpolation Filter Passband Ripple

Table 6. Normal x2 Interpolation Filter

Parameter	Condition	Value (Typ)	Value (Max)	Units
Filter gain pass band	0 ……. $0.45f_S$		±0.02	dB
Filter gain stop band	$0.55f_S$ ….. $7.455f_S$	–60		dB
Filter group delay		$22t_S$		s

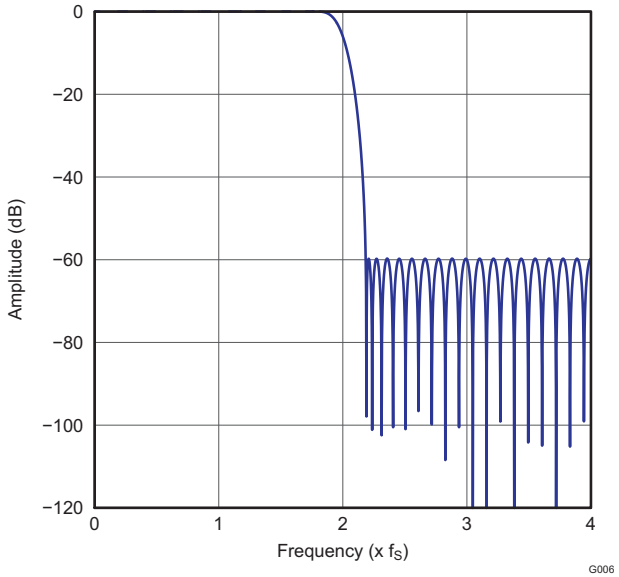


Figure 21. Normal x2 Interpolation Filter Frequency Response

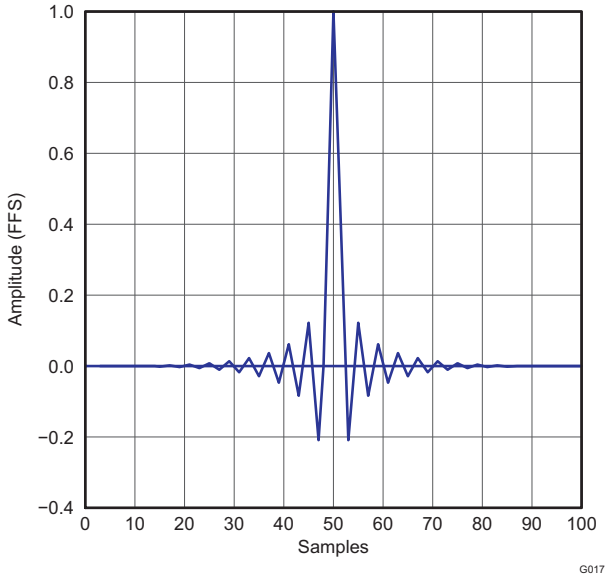


Figure 22. Normal x2 Interpolation Filter Impulse Response

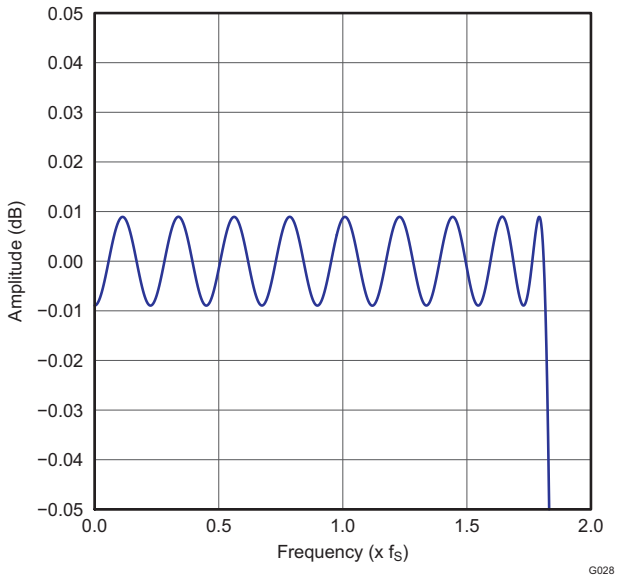


Figure 23. Normal x2 Interpolation Filter Passband Ripple

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The low-latency x8 / x4 / x2 / x1 (bypass) interpolation filter is programmed for sample rates from 8 kHz to 384 kHz.

Table 7. Low Latency x8 Interpolation Filter

Parameter	Condition	Value (Typ)	Units
Filter gain pass band	0 ……. $0.45f_S$	±0.0001	dB
Filter gain stop band	$0.55f_S$ ….. $7.455f_S$	–52	dB
Filter group delay		$3.5t_S$	s

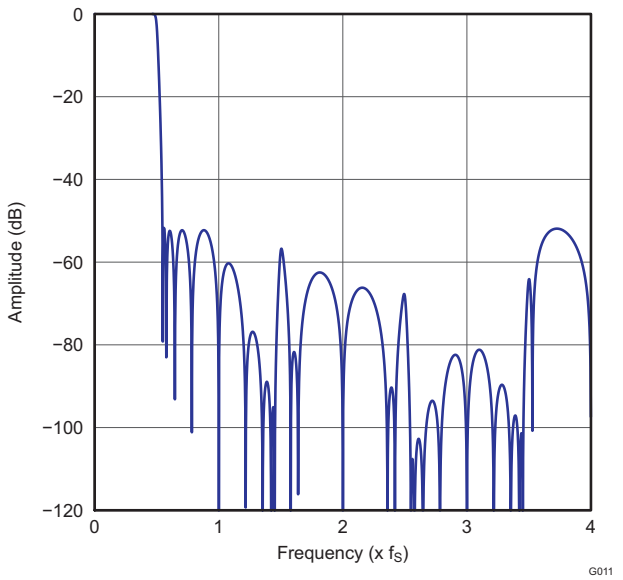


Figure 24. Low Latency x8 Interpolation Filter Frequency Response

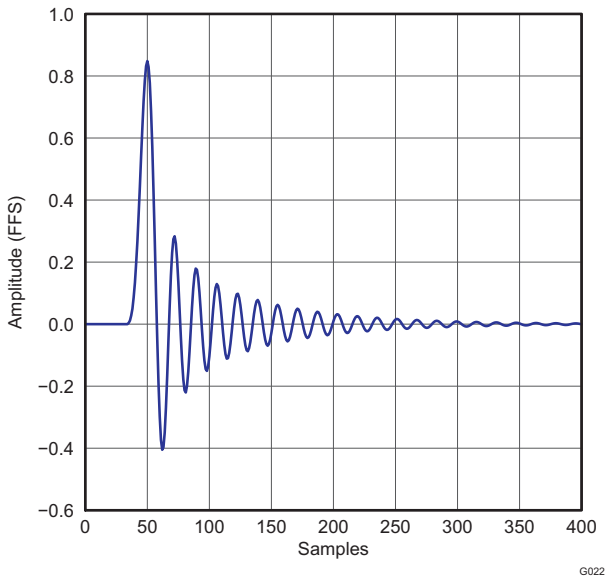


Figure 25. Low Latency x8 Interpolation Filter Impulse Response

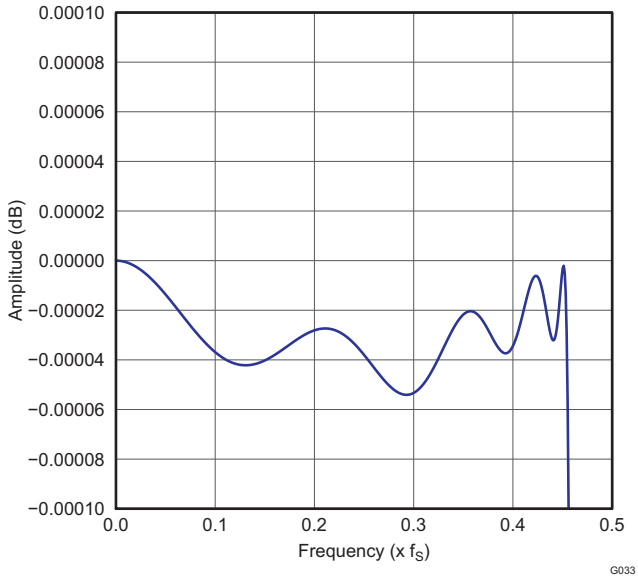


Figure 26. Low Latency x8 Interpolation Filter Passband Ripple

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Table 8. Low Latency x4 Interpolation Filter

Parameter	Condition	Value (Typ)	Units
Filter gain pass band	0 ……. $0.45f_S$	±0.0001	dB
Filter gain stop band	$0.55f_S$ ….. $3.455f_S$	–52	dB
Filter group delay		$3.5t_S$	s

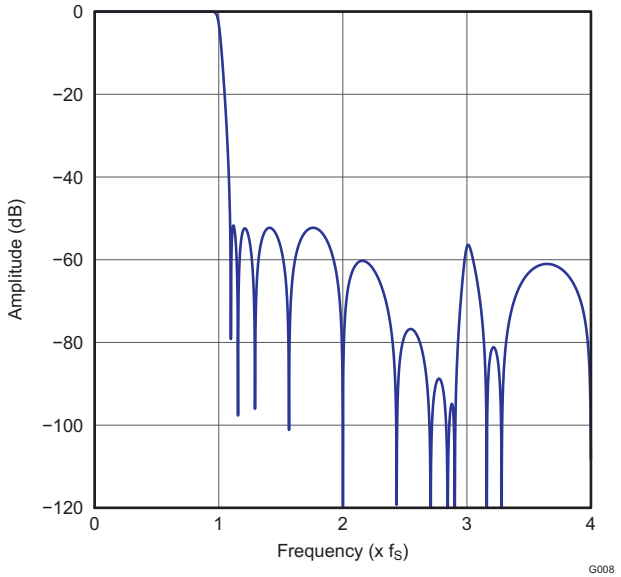


Figure 27. Low Latency x4 Interpolation Filter Frequency Response

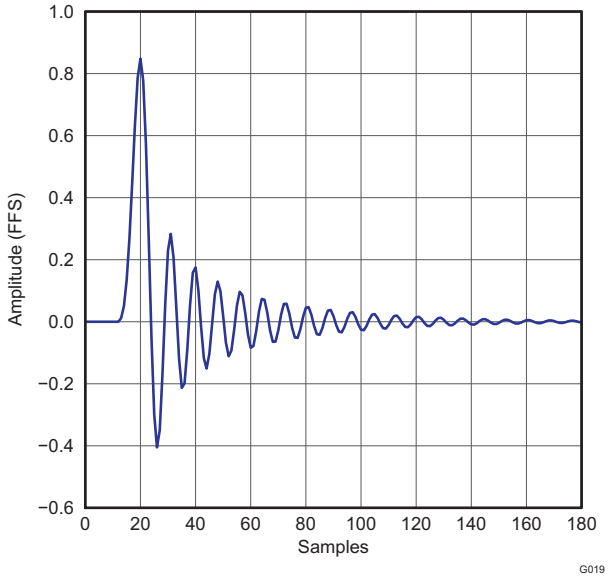


Figure 28. Low Latency x4 Interpolation Filter Impulse Response

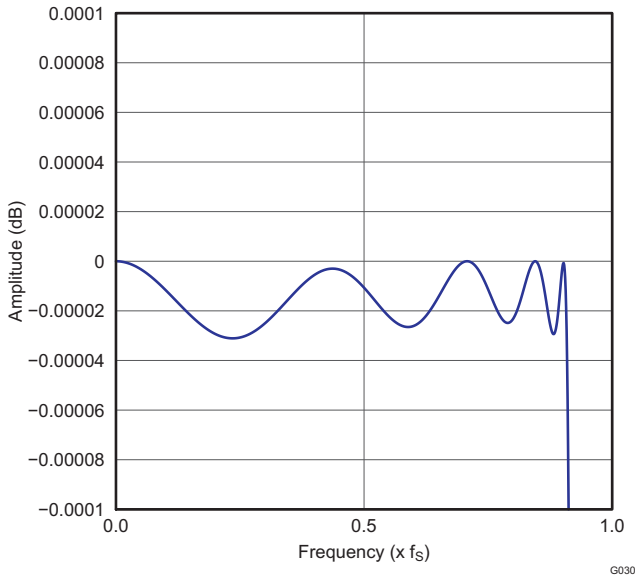


Figure 29. Low Latency x4 Interpolation Filter Passband Ripple

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Table 9. Low Latency x2 Interpolation Filter

Parameter	Condition	Value (Typ)	Units
Filter gain pass band	0 ……. $0.45f_S$	±0.0001	dB
Filter gain stop band	$0.55f_S$ ….. $1.455f_S$	–52	dB
Filter group delay		$3.5t_S$	s

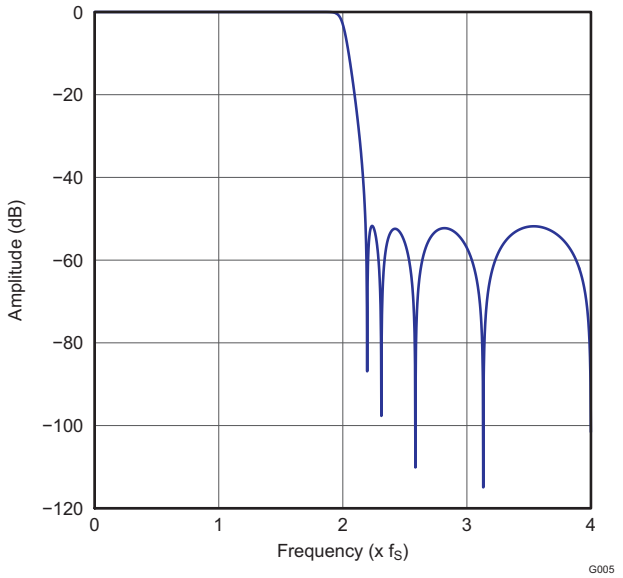


Figure 30. Low Latency x2 Interpolation Filter Frequency Response

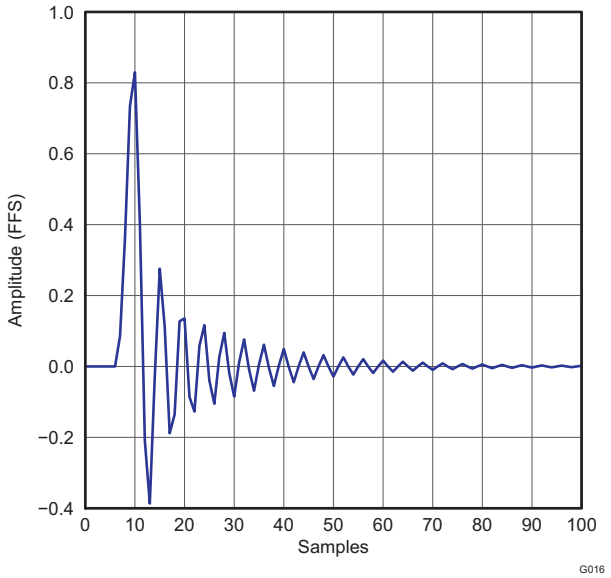


Figure 31. Low Latency x2 Interpolation Filter Impulse Response

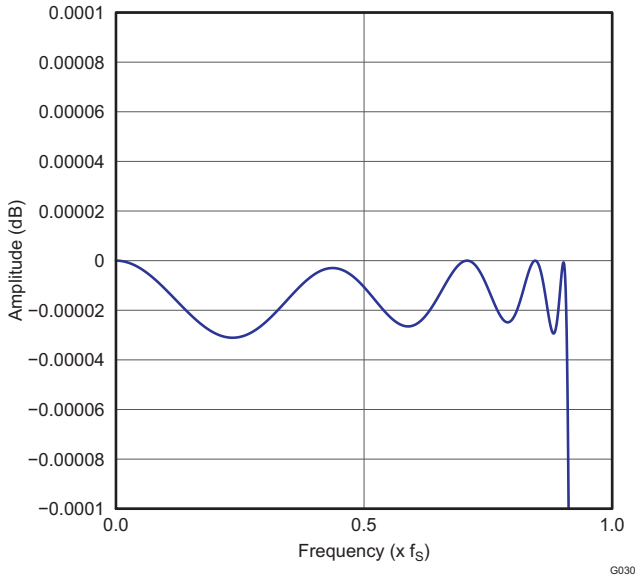


Figure 32. Low Latency x2 Interpolation Filter Passband Ripple

9.3.5 Reset and System Clock Functions

9.3.5.1 Clocking Overview

The PCM510xA devices have flexible systems for clocking. Internally, the device requires a number of clocks, mostly at related clock rates to function correctly. All of these clocks can be derived from the serial audio interface in one form or another.

The data flows at the sample rate (f_S). Once the data is brought into the serial audio interface, it gets processed, interpolated and modulated all the way to 128 × f_S before arriving at the current segments for the final digital to analog conversion.

The serial audio interface typically has 4 connections SCK (system master clock), BCK (bit clock), LRCK (left right word clock) and DIN (data). The device has an internal PLL that is used to take either SCK or BCK and create the higher rate clocks required by the interpolating processor and the DAC clock. This allows the device to operate with or without an external SCK.

9.3.5.2 Clock Slave Mode With Master/System Clock (SCK) Input (4 Wire I^2S)

The PCM510xA requires a system clock to operate the digital interpolation filters and advanced segment DAC modulators. The system clock is applied at the SCK input and supports up to 50 MHz. The PCM510xA system-clock detection circuit automatically senses the system-clock frequency. Common audio sampling frequencies in the bands of 8 kHz, 16 kHz, (32 kHz - 44.1 kHz - 48 kHz), (88.2kHz - 96kHz), (176.4 kHz - 192 kHz), and 384 kHz with ±4% tolerance are supported. Values in the parentheses are grouped when detected, e.g. 88.2kHZ and 96kHz are detected as "double rate," 32kHz, 44.1kHz and 48kHz will be detected as "single rate".

The sampling frequency detector sets the clock for the digital filter, Delta Sigma Modulator (DSM) and the Negative Charge Pump (NCP) automatically. Table 10 shows examples of system clock frequencies for common audio sampling rates.

SCK rates that are not common to standard audio clocks, between 1 MHz and 50 MHz, are only supported in software mode, available only in the PCM512x, PCM514x, and PCM5242 devices, by configuring various PLL and clock-divider registers. This programmability allows the device to become a clock master and drive the host serial port with LRCK and BCK, from a non-audio related clock (for example, using 12 MHz to generate 44.1 kHz [LRCK] and 2.8224 MHz [BCK]).

Table 10. System Master Clock Inputs for Audio Related Clocks

Sampling Frequency	System Clock Frequency (f_{SCK}) (MHz)											
	64 f_S	128 f_S	192 f_S	256 f_S	384 f_S	512 f_S	768 f_S	1024 f_S	1152 f_S	1536 f_S	2048 f_S	3072 f_S
8 kHz	–(1)	1.024(2)	1.536(2)	2.048	3.072	4.096	6.144	8.192	9.216	12.288	16.384	24.576
16 kHz	–(1)	2.048(2)	3.072(2)	4.096	6.144	8.192	12.288	16.384	18.432	24.576	36.864	49.152
32 kHz	–(1)	4.096(2)	6.144(2)	8.192	12.288	16.384	24.576	32.768	36.864	49.152	–(1)	–(1)
44.1 kHz	–(1)	5.6488(2)	8.4672(2)	11.2896	16.9344	22.5792	33.8688	45.1584	–(1)	–(1)	–(1)	–(1)
48 kHz	–(1)	6.144(2)	9.216(2)	12.288	18.432	24.576	36.864	49.152	–(1)	–(1)	–(1)	–(1)
88.2 kHz	–(1)	11.2896(2)	16.9344	22.5792	33.8688	45.1584	–(1)	–(1)	–(1)	–(1)	–(1)	–(1)
96 kHz	–(1)	12.288(2)	18.432	24.576	36.864	49.152	–(1)	–(1)	–(1)	–(1)	–(1)	–(1)
176.4 kHz	–(1)	22.579	33.8688	45.1584	–(1)	–(1)	–(1)	–(1)	–(1)	–(1)	–(1)	–(1)
192 kHz	–(1)	24.576	36.864	49.152	–(1)	–(1)	–(1)	–(1)	–(1)	–(1)	–(1)	–(1)
384 kHz	24.576	49.152	–(1)	–(1)	–(1)	–(1)	–(1)	–(1)	–(1)	–(1)	–(1)	–(1)

(1) This system clock rate is not supported for the given sampling frequency.
(2) This system clock rate is supported by PLL mode.

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9.3.5.3 Clock Slave Mode with BCK PLL to Generate Internal Clocks (3-Wire PCM)

The system clock PLL mode allows designers to use a simple 3-wire I^2S audio source. The 3-wire source reduces the need for a high frequency SCK, making PCB layout easier, and reduces high frequency electromagnetic interference.

The internal PLL is disabled as soon as an external SCK is supplied.

The device starts up expecting an external SCK input, but if BCK and LRCK start correctly while SCK remains at ground level for 16 successive LRCK periods, then the internal PLL starts, automatically generating an internal SCK from the BCK reference. Specific BCK rates are required to generate an appropriate master clock. Table 11 describes the minimum and maximum BCK per LRCK for the integrated PLL to automatically generate an internal SCK.

Table 11. BCK Rates (MHz) by LRCK Sample Rate for PCM510xA PLL Operation

	BCK (f_S)	
Sample f (kHz)	32	64
8	–	–
16	–	1.024
32	1.024	2.048
44.1	1.4112	2.8224
48	1.536	3.072
96	3.072	6.144
192	6.144	12.288
384	12.288	24.576

9.4 Device Functional Modes

9.4.1 External SCK and PLL Activation

As discussed in *Clock Slave Mode with BCK PLL to Generate Internal Clocks (3-Wire PCM)*, the internal PLL of a PCM510xA device supplies a SCK if an external SCK is not present at powerup.

9.4.1.1 Interpolation Filter Modes

Interpolation-filter options are controlled by the FLT pin. See Table 3.

9.4.1.2 44.1kHz De-emphasis

De-emphasis control for 44.1-kHz f_S is controlled by the DEMP pin. See *Pin Configuration and Functions*.

9.4.1.3 Audio Format

Audio format is selected by the FMT pin. See *Pin Configuration and Functions*.

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10 Applications and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

10.1 Application Information

10.1.1 Typical Applications

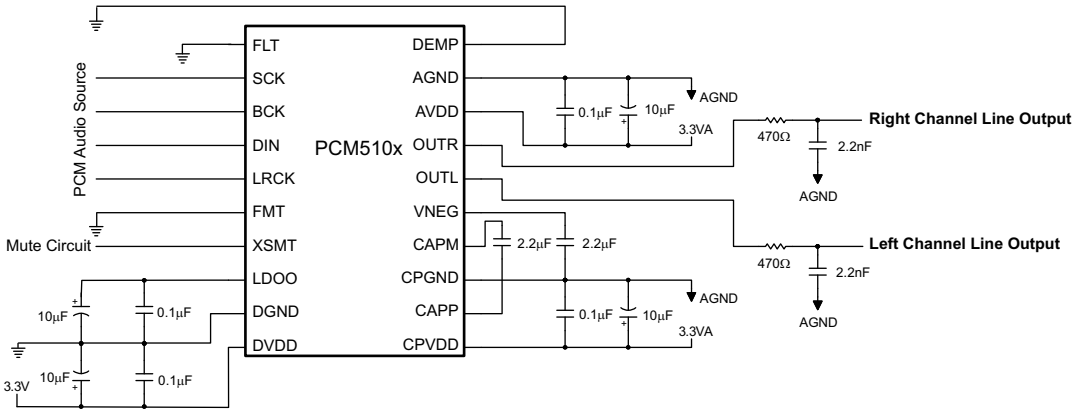


Figure 33. Simplified Schematic, Hardware-Controlled Subsystem

10.1.1.1 Example Design Requirements

- Device control method: hardware control
  - Normal filter latency
  - I^2S digital audio interface
  - Power rail monitoring from the system 12-V rail to mute early on system power loss
- Single-ended 2.1-V_{RMS} analog outputs
- 3-wire I^2S interface (BCK PLL)
- Single 3.3-V supply

10.1.1.2 Detailed Design Procedure

- Device control method: See *Pin Configuration and Functions* and *Audio Processing*.
  - Normal filter latency: FLT pin tied low
  - Audio format selection: FMT pin tied low
- Clock and PLL setup (See *Reset and System Clock Functions*). Ensure incoming BCK meets minimum requirements.
- XSMT pin setup for 12-V monitoring (See *External Power Sense Undervoltage Protection Mode*).
- Single-supply 3.3-V operation (See *Setting Digital Power Supplies and I/O Voltage Rails*)

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Application Information (continued)

10.1.1.3 Application Curve

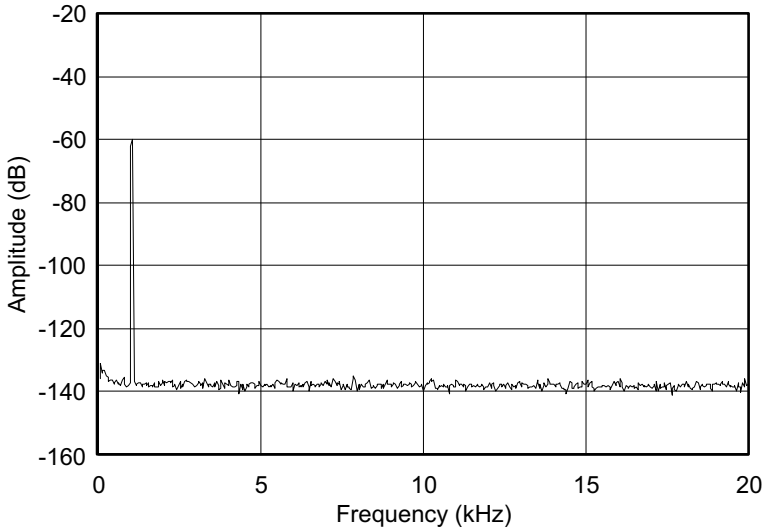


Figure 34. PCM5101A FFT Plot, DC to 20 kHz with a 1 kHz, –60dBFS Input

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11 Power Supply Recommendations

11.1 Power Supply Distribution and Requirements

The PCM510xA devices are powered through the following pins:

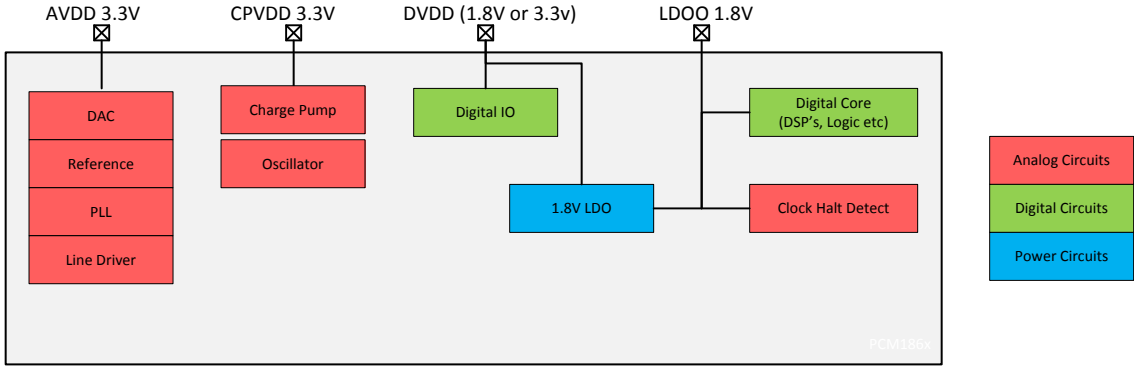


Figure 35. Power Distribution Tree within PCM510xA

Table 12. Power Supply Pin Descriptions

NAME	USAGE / DESCRIPTION
AVDD	Analog voltage supply; must be 3.3 V. This powers all analog circuitry that the DAC runs on.
DVDD	Digital voltage supply. This is used as the I/O voltage control and the input to the onchip LDO.
CPVDD	Charge Pump Voltage Supply - must be 3.3 V
LDOO	Output from the onchip LDO. Should be used with a 0.1-µF decoupling cap. Can be driven (used as power input) with a 1.8-V supply to bypass the onchip LDO for lower power consumption.
AGND	Analog ground
DGND	Digital ground

11.2 Recommended Powerdown Sequence

Under certain conditions, the PCM510xA devices can exhibit some pop on power down. Pops are caused by a device not having enough time to detect power loss and start the muting process.

The PCM510xA devices have two auto-mute functions to mute the device upon power loss (intentional or unintentional).

XSMT = 0

When the XSMT pin is pulled low, the incoming PCM data is attenuated to 0, closely followed by a hard analog mute. This process takes 150 sample times (t_s) + 0.2 ms.

Because this mute time is mainly dominated by the sampling frequency, systems sampling at 192 kHz will mute much faster than a 48-kHz system.

Clock Error Detect

When clock error is detected on the incoming data clock, the PCM510xA devices switch to an internal oscillator, and continue to the drive the output, while attenuating the data from the last known value. Once this process is complete, the PCM510xA outputs are hard muted to ground.

11.2.1 Planned Shutdown

These auto-muting processes can be manipulated by system designs to mute before power loss in the following ways:

1. Assert XSMT low 150 t_S + 0.2 ms before power is removed.

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Recommended Powerdown Sequence (continued)

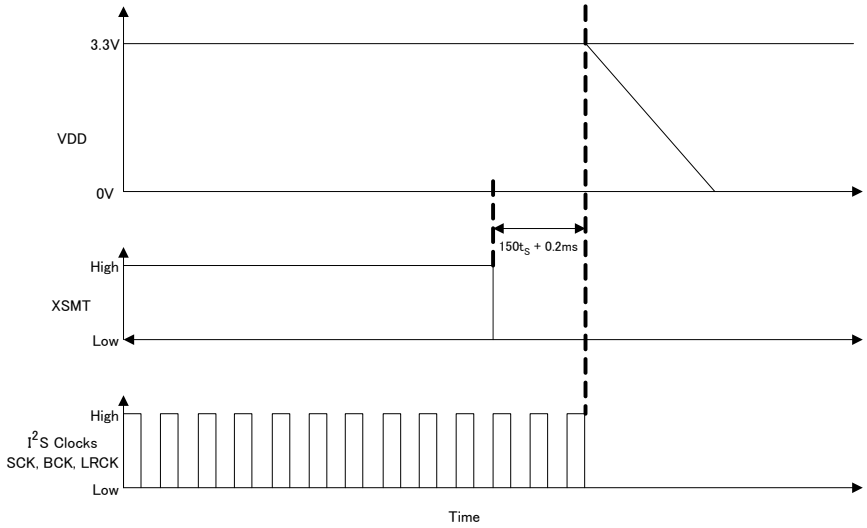


Figure 36. Assert XSMT

2. Stop I^2S clocks (SCK, BCK, LRCK) 3 ms before powerdown as shown in Figure 37.

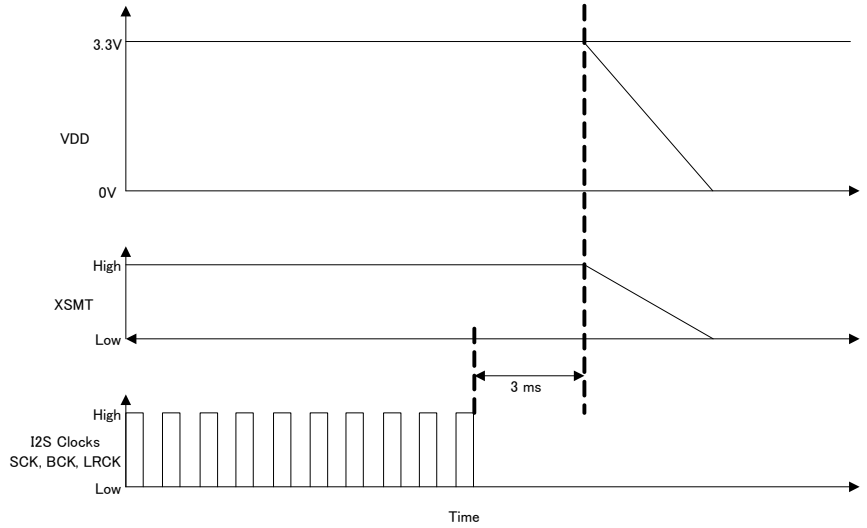


Figure 37. Stop I^2C Clocks

11.2.2 Unplanned Shutdown

Many systems use a low-noise regulator to provide an AVDD 3.3-V supply for the DAC. The XSMT Pin can take advantage of such a feature to measure the pre-regulated output from the system SMPS to mute the output before the entire SMPS discharges. Figure 38 shows how to configure such a system to use the XSMT pin. The XSMT pin can also be used in parallel with a GPIO pin from the system microcontroller/DSP or power supply.

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Recommended Powerdown Sequence (continued)

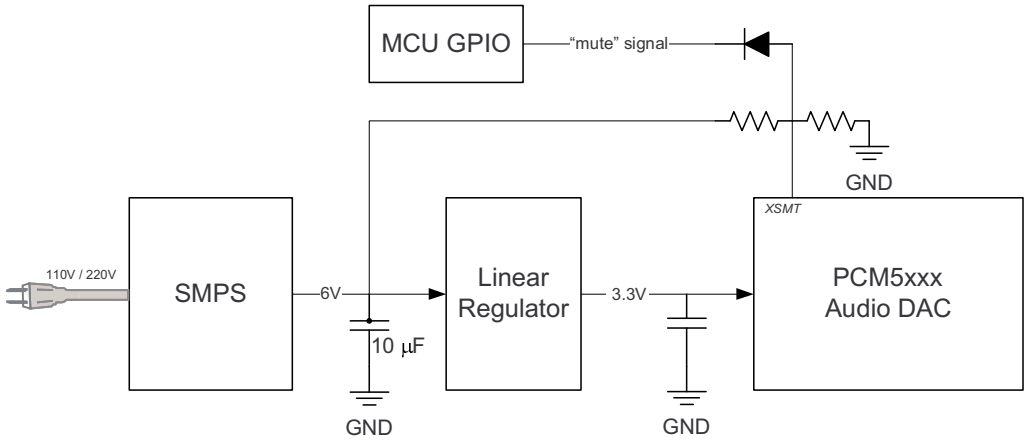


Figure 38. Using the XSMT Pin

11.3 External Power Sense Undervoltage Protection Mode

NOTE

External Power Sense Undervoltage Protection Mode is supported only when DVDD = 3.3 V.

The XSMT pin can also be used to monitor a system voltage, such as the 24-VDC LCD TV backlight, or 12-VDC system supply using a voltage divider created with two resistors. (See Figure 39)

- If the XSMT pin makes a transition from “1” to “0” over 6 ms or more, the device switches into external under-voltage protection mode. This mode uses two trigger levels:
  - When the XSMT pin level reaches 2 V, soft mute process begins.
  - When the XSMT pin level reaches 1.2 V, analog mute engages, regardless of digital audio level, and analog shutdown begins. (DAC and related circuitry powers down).

If XSMT is moved from "1" to "0" in 20 ns or less, then the device will interpret it as a digital controlled request to mute. It will perform a soft mute, then move to standby.

A timing diagram to show this is shown in Figure 40.

NOTE

The XSMT input pin voltage range is from –0.3 V to DVDD+0.3 V. The ratio of external resistors must produce a voltage within this input range. Any increase in power supply (such as power supply positive noise or ripple) can pull the XSMT pin higher than DVDD+0.3 V.

For example, if the PCM510xA is monitoring a 12-V input, and dividing the voltage by 4, then the voltage at XSMT during ideal power supply conditions is 3.3 V. A voltage spike higher than 14.4 V causes a voltage greater than 3.6 V (DVDD+0.3) on the XSMT pin, potentially damaging the device.

Providing the divider is set appropriately, any DC voltage can be monitored.

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External Power Sense Undervoltage Protection Mode (continued)

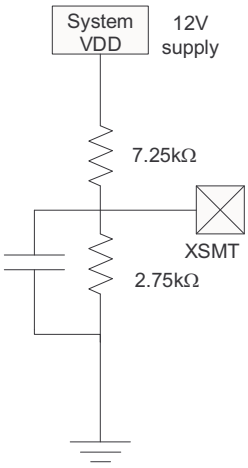


Figure 39. XSMT in External UVP Mode

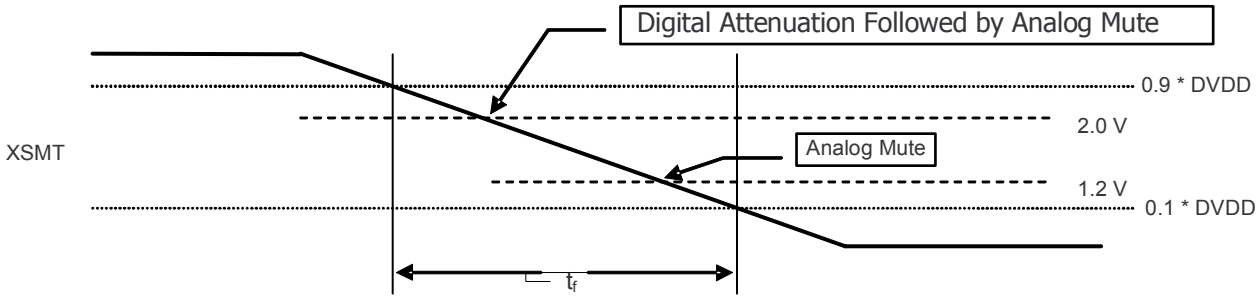


Figure 40. XSMT Timing for Undervoltage Protection

The trigger voltage values for the soft mute and hard mute are shown in Table 13. The range of values will vary from device to device, but typical thresholds are shown. XSMT should be set up to nominally be 3.3 V along with DVDD, but derived from a higher system power supply rail.

Table 13. Distribution of Voltage Thresholds

	MIN	TYP	MAX
Soft Mute Threshold Voltage	2.0 V	2.2 V	0.9×DVDD
Hard Mute Threshold Voltage	0.1×DVDD	0.9 V	1.2 V

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11.4 Power-On Reset Function

Power-On Reset, DVDD 3.3-V Supply

The PCM510xA includes a power-on reset function shown in Figure 41. With V_{DD} > 2.8 V, the power-on reset function is enabled. After the initialization period, the PCM510xA is set to its default reset state. Analog output will begin ramping after valid data has been passing through the device for the given group delay given by the digital interpolation filter selected.

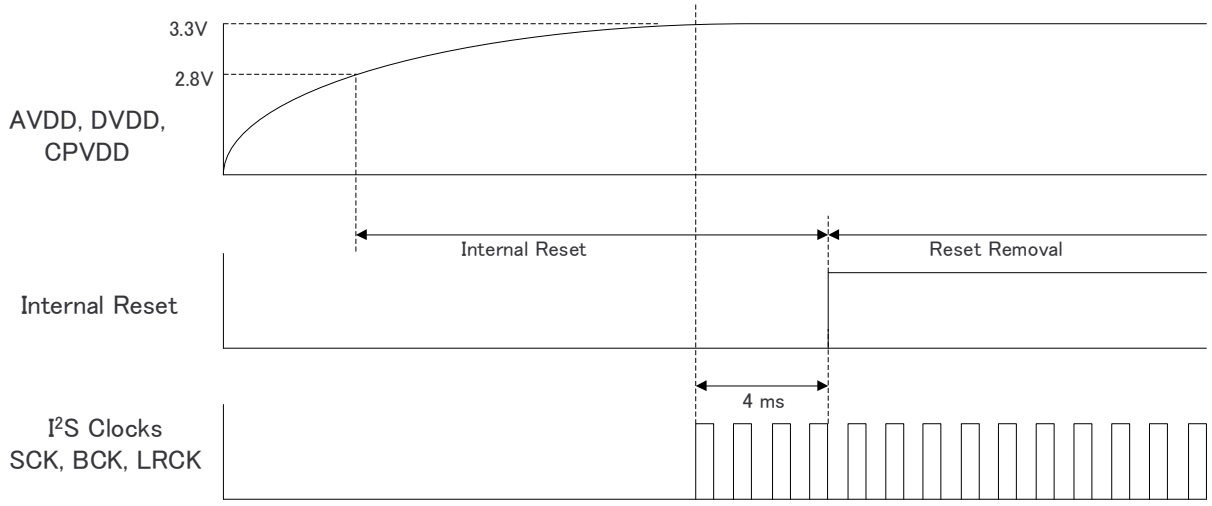


Figure 41. Power-On Reset Timing, DVDD = 3.3 V

Power-On Reset, DVDD 1.8-V Supply

The PCM510xA includes a power-on reset function shown in Figure 42 operating at DVDD = 1.8 V. With AVDD greater than approximately 2.8 V, CPVDD greater than approximately 2.8 V, and DVDD greater than approximately 1.5 V, the power-on reset function is enabled. After the initialization period, the PCM510xA is set to its default reset state.

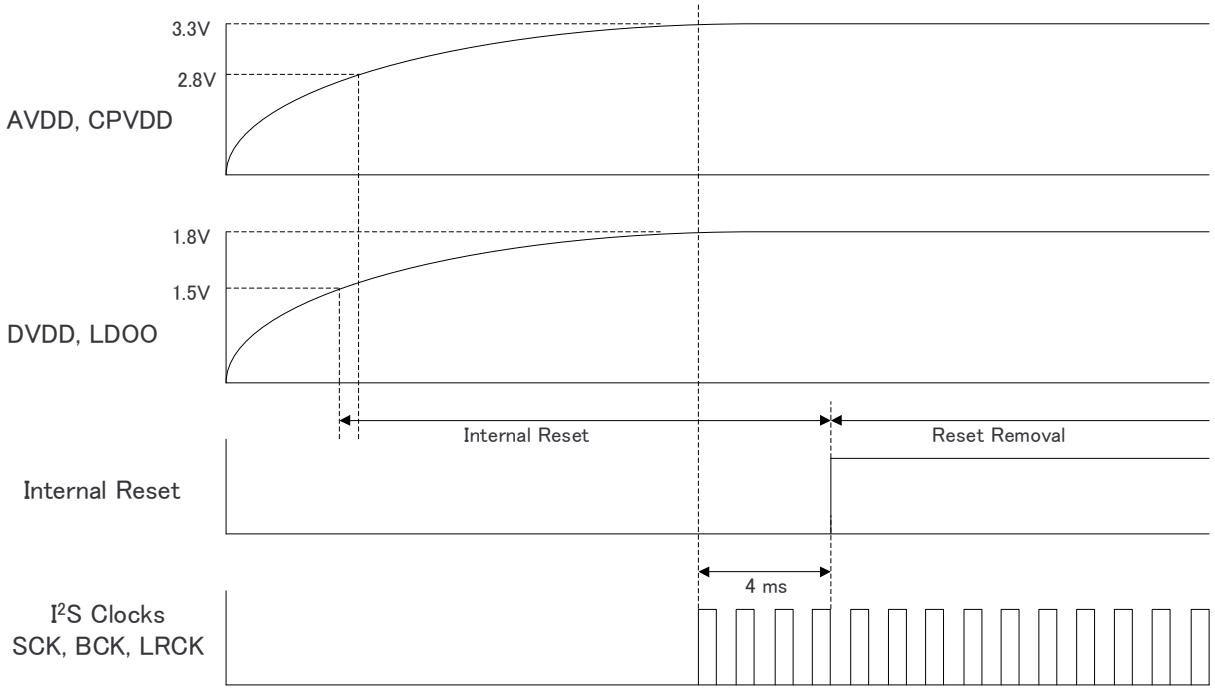


Figure 42. Power-On Reset Timing, DVDD = 1.8 V

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11.5 PCM510xA Power Modes

11.5.1 Setting Digital Power Supplies and I/O Voltage Rails

The internal digital core of the PCM510xA devices run from a 1.8-V supply. This can be generated by the internal LDO, or by an external 1.8-V supply.

DVDD is used to set the I/O voltage, and to be used as the input to the onchip LDO that creates the 1.8 V required by the digital core.

For systems that require 3.3 V I/O support, but lower power consumption, DVDD should be connected to 3.3 V and LDOO can be connected to an external 1.8-V source. Doing so will disable the onchip LDO.

When setting I/O voltage to be 1.8 V, both DVDD and LDOO must be provided with an external 1.8-V supply.

11.5.2 Power Save Modes

The PCM510xA devices offer two power-save modes: standby and power-down.

When a clock error (SCK, BCK, and LRCK) or clock halt is detected, the PCM510xA device automatically enters standby mode. The DAC and line driver are also powered down.

When BCK and LRCK remain at a low level for more than 1 second, the PCM510xA device automatically enters powerdown mode. Power-down mode disables the negative charge pump and bias/reference circuit, in addition to those disabled in standby mode.

When expected audio clocks (SCK, BCK, LRCK) are applied to the PCM510xA device, or if BCK and LRCK start correctly while SCK remains at ground level for 16 successive LRCK periods, the device starts its powerup sequence automatically.

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12 Layout

12.1 Layout Guidelines

- The PCM510xA family of devices are simple to layout. Most engineers use a shared common ground for an entire device. GND can be consider AGND and DGND connected.
- Good system partitioning should keep digital clock and interface traces away from the analog outputs for highest analog performance. This reduces any high speed clock return currents influencing the analog outputs.
- Power supply and charge pump decoupling capacitors should be placed as close as possible to the device.
- The top layer should be used for routing signals, whilst the bottom layer can be used for GND.

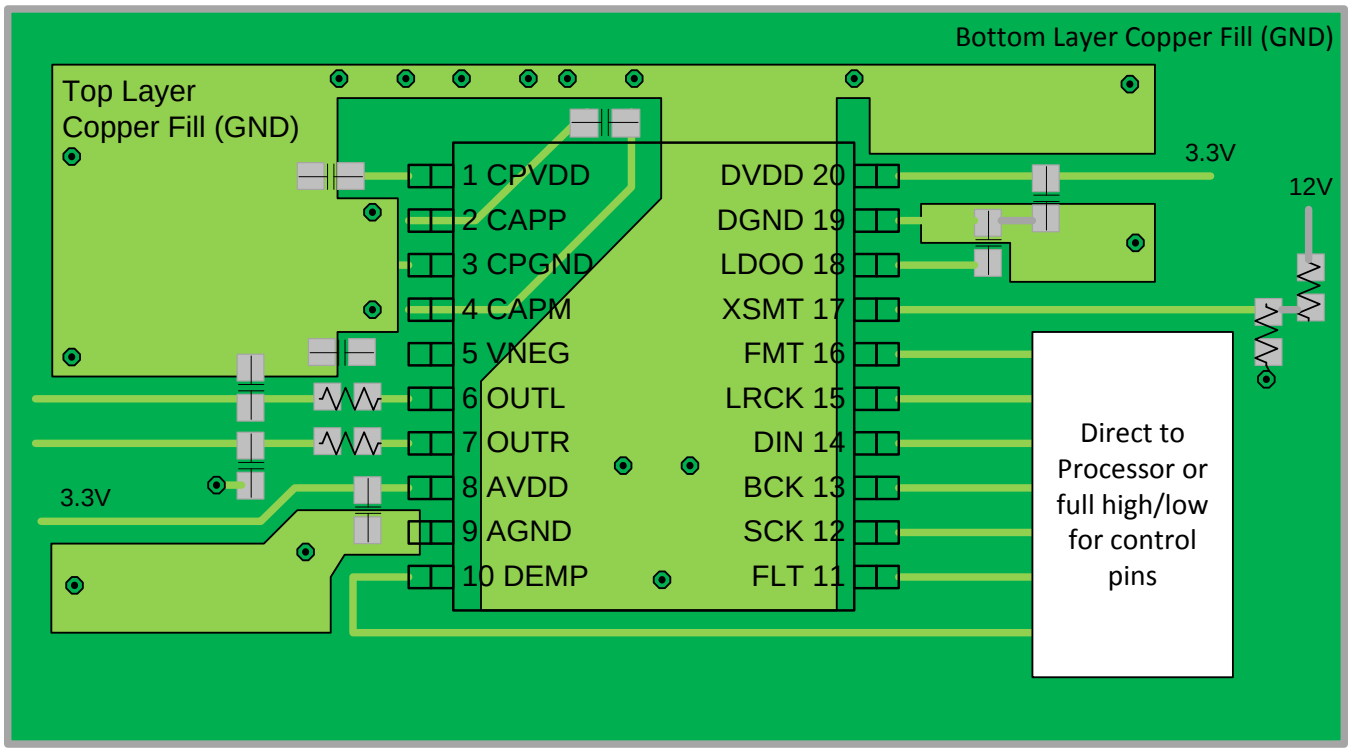


Figure 43. PCM510x Layout Example

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13 Device and Documentation Support

13.1 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 14. Related Links

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
PCM5100A	Click here	Click here	Click here	Click here	Click here
PCM5101A	Click here	Click here	Click here	Click here	Click here
PCM5102A	Click here	Click here	Click here	Click here	Click here
PCM5100A-Q1	Click here	Click here	Click here	Click here	Click here
PCM5101A-Q1	Click here	Click here	Click here	Click here	Click here
PCM5102A-Q1	Click here	Click here	Click here	Click here	Click here

13.2 Community Resources

E2E™ Audio Converters Forum TI

E2E Community

13.3 Trademarks

Directpath is a trademark of Texas Instruments, Inc.
System Two Cascade, Audio Precision are trademarks of Audio Precision.

13.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

14 Mechanical, Packaging, and Orderable Information

The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, see the left-hand navigation.

14.1 Mechanical Data

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PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package | Pins	Package qty | Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
PCM5100APW	Active	Production	TSSOP (PW) | 20	70 | TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-25 to 85	PCM5100A
PCM5100APW.A	Active	Production	TSSOP (PW) | 20	70 | TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-25 to 85	PCM5100A
PCM5100APWR	Active	Production	TSSOP (PW) | 20	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-25 to 85	PCM5100A
PCM5100APWR.A	Active	Production	TSSOP (PW) | 20	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-25 to 85	PCM5100A
PCM5100APWRG4	Active	Production	TSSOP (PW) | 20	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-25 to 85	PCM5100A
PCM5100APWRG4.A	Active	Production	TSSOP (PW) | 20	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-25 to 85	PCM5100A
PCM5100AQPWRQ1	Active	Production	TSSOP (PW) | 20	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	P5100AQ1
PCM5100AQPWRQ1.A	Active	Production	TSSOP (PW) | 20	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	P5100AQ1
PCM5101APW	Active	Production	TSSOP (PW) | 20	70 | TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-25 to 85	PCM5101A
PCM5101APW.A	Active	Production	TSSOP (PW) | 20	70 | TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-25 to 85	PCM5101A
PCM5101APWR	Active	Production	TSSOP (PW) | 20	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-25 to 85	PCM5101A
PCM5101APWR.A	Active	Production	TSSOP (PW) | 20	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-25 to 85	PCM5101A
PCM5101AQPWRQ1	Active	Production	TSSOP (PW) | 20	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	P5101AQ1
PCM5101AQPWRQ1.A	Active	Production	TSSOP (PW) | 20	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	P5101AQ1
PCM5102APW	Active	Production	TSSOP (PW) | 20	70 | TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-25 to 85	PCM5102A
PCM5102APW.A	Active	Production	TSSOP (PW) | 20	70 | TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-25 to 85	PCM5102A
PCM5102APWG4	Active	Production	TSSOP (PW) | 20	70 | TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-25 to 85	PCM5102A
PCM5102APWG4.A	Active	Production	TSSOP (PW) | 20	70 | TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-25 to 85	PCM5102A
PCM5102APWR	Active	Production	TSSOP (PW) | 20	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-25 to 85	PCM5102A
PCM5102APWR.A	Active	Production	TSSOP (PW) | 20	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-25 to 85	PCM5102A
PCM5102AQPWRQ1	Active	Production	TSSOP (PW) | 20	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	P5102AQ1
PCM5102AQPWRQ1.A	Active	Production	TSSOP (PW) | 20	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	P5102AQ1

(1) **Status:** For more details on status, see our product life cycle.

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF PCM5100A, PCM5100A-Q1, PCM5101A, PCM5101A-Q1, PCM5102A, PCM5102A-Q1 :

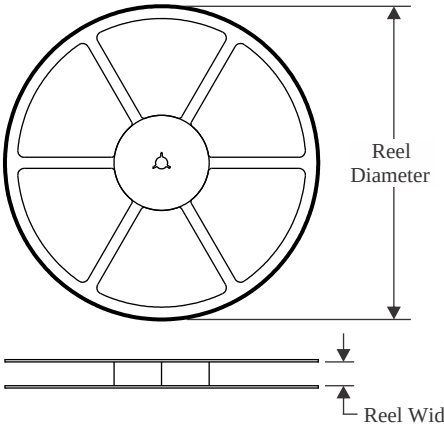
- Catalog : PCM5100A, PCM5101A, PCM5102A
- Automotive : PCM5100A-Q1, PCM5101A-Q1, PCM5102A-Q1

NOTE: Qualified Version Definitions:

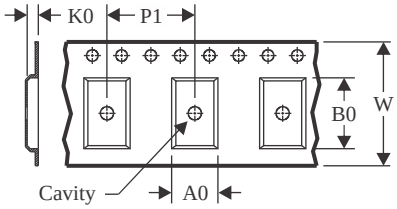
- Catalog - TI's standard catalog product
- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

TAPE AND REEL INFORMATION

REEL DIMENSIONS

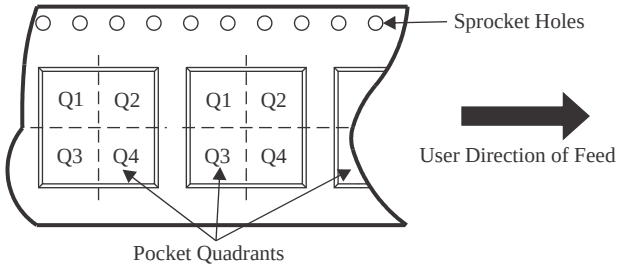


TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

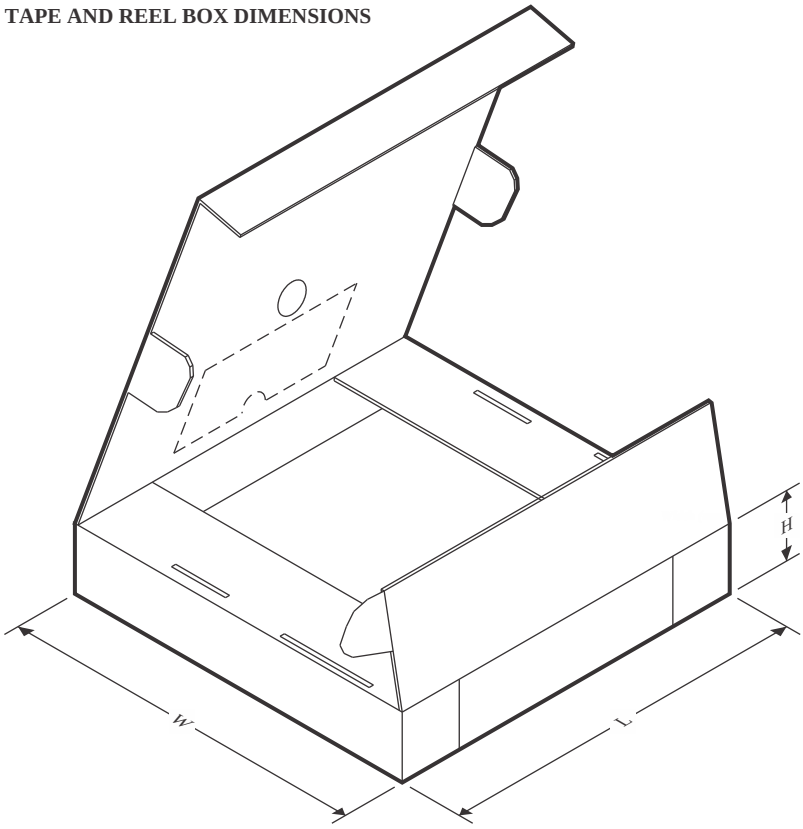
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
PCM5100APWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1
PCM5100APWRG4	TSSOP	PW	20	2000	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1
PCM5100AQPWRQ1	TSSOP	PW	20	2000	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1
PCM5101APWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1
PCM5101AQPWRQ1	TSSOP	PW	20	2000	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1
PCM5102APWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1
PCM5102AQPWRQ1	TSSOP	PW	20	2000	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1

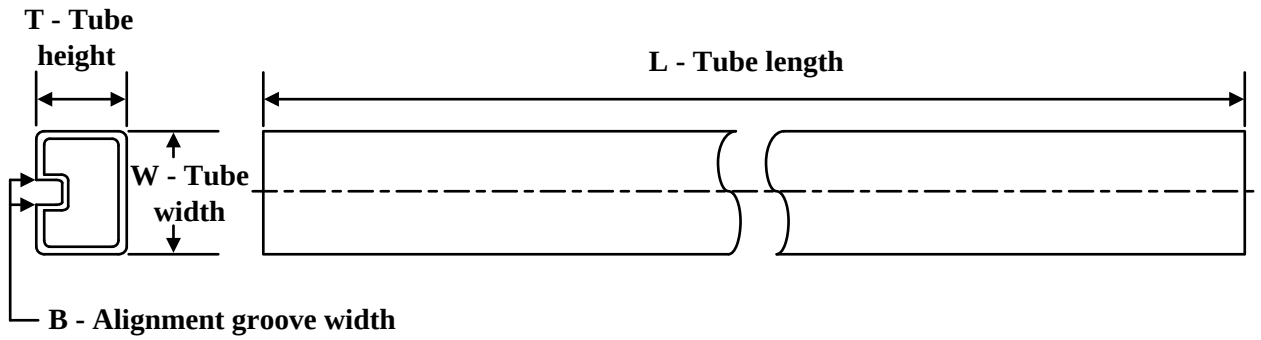
TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
PCM5100APWR	TSSOP	PW	20	2000	350.0	350.0	43.0
PCM5100APWRG4	TSSOP	PW	20	2000	350.0	350.0	43.0
PCM5100AQPWRQ1	TSSOP	PW	20	2000	350.0	350.0	43.0
PCM5101APWR	TSSOP	PW	20	2000	350.0	350.0	43.0
PCM5101AQPWRQ1	TSSOP	PW	20	2000	350.0	350.0	43.0
PCM5102APWR	TSSOP	PW	20	2000	350.0	350.0	43.0
PCM5102AQPWRQ1	TSSOP	PW	20	2000	350.0	350.0	43.0

TUBE



*All dimensions are nominal

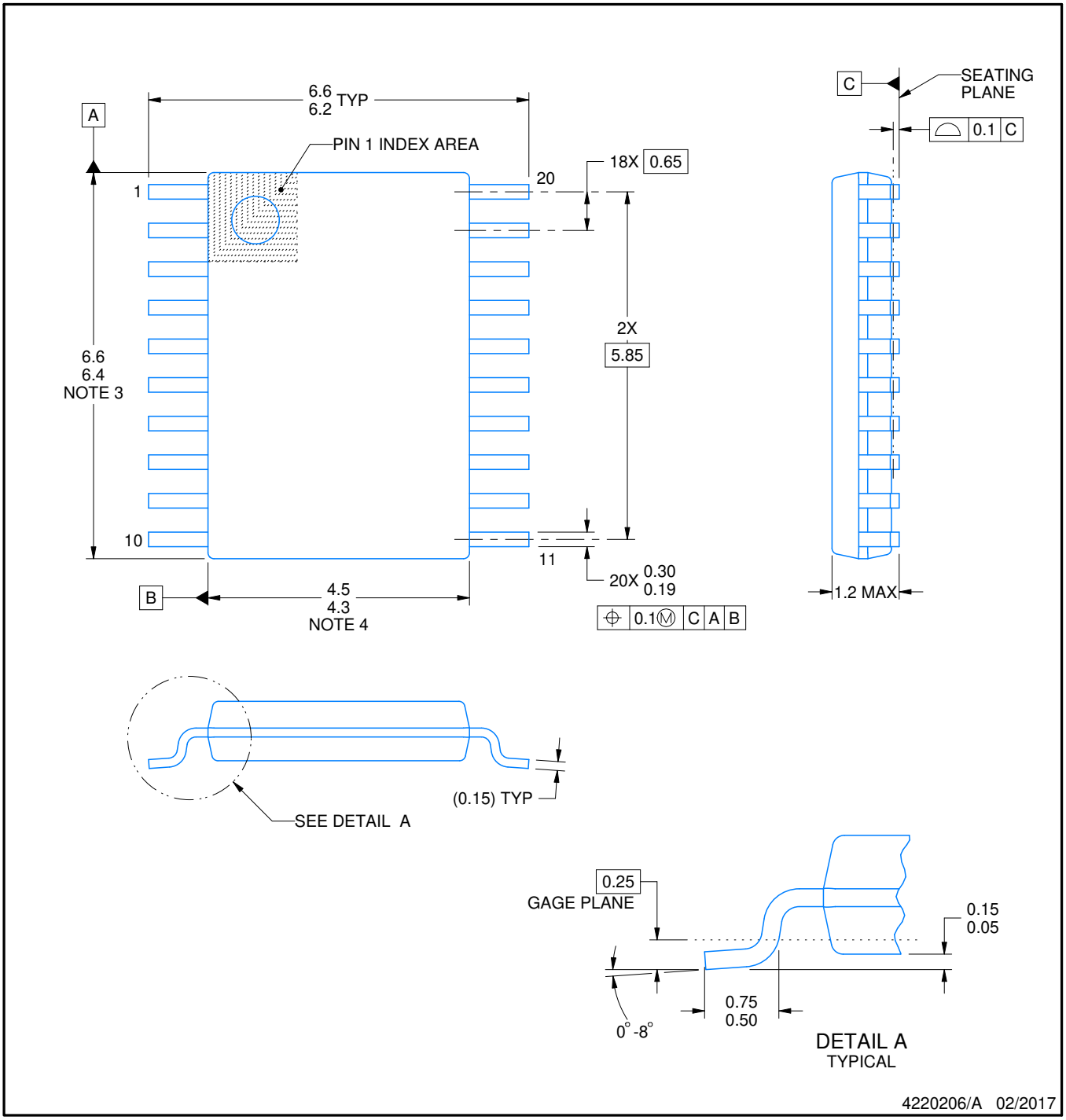
Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
PCM5100APW	PW	TSSOP	20	70	530	10.2	3600	3.5
PCM5100APW.A	PW	TSSOP	20	70	530	10.2	3600	3.5
PCM5101APW	PW	TSSOP	20	70	530	10.2	3600	3.5
PCM5101APW.A	PW	TSSOP	20	70	530	10.2	3600	3.5
PCM5102APW	PW	TSSOP	20	70	530	10.2	3600	3.5
PCM5102APW.A	PW	TSSOP	20	70	530	10.2	3600	3.5
PCM5102APWG4	PW	TSSOP	20	70	530	10.2	3600	3.5
PCM5102APWG4.A	PW	TSSOP	20	70	530	10.2	3600	3.5

PACKAGE OUTLINE

PW0020A

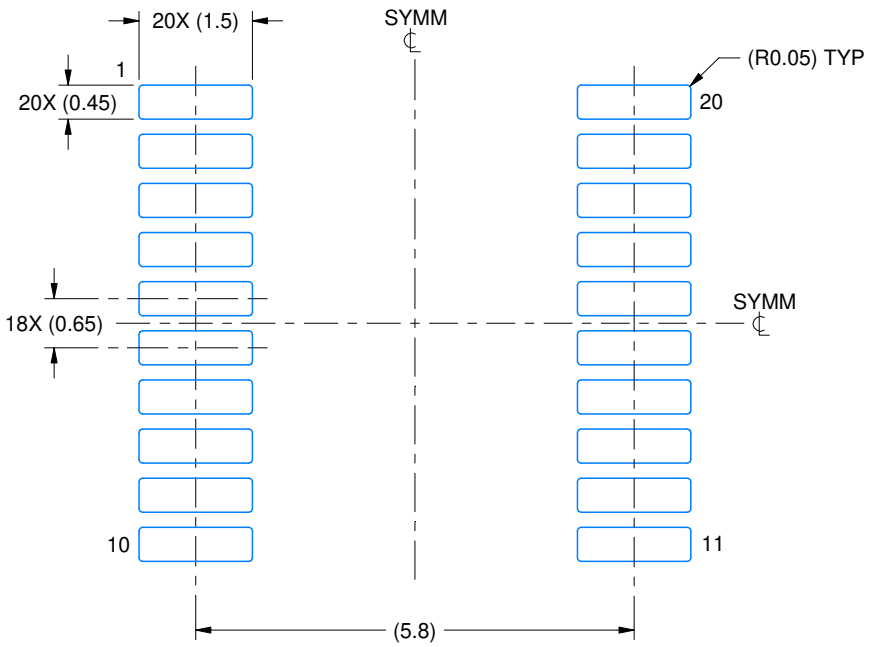
TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-153.



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 10X

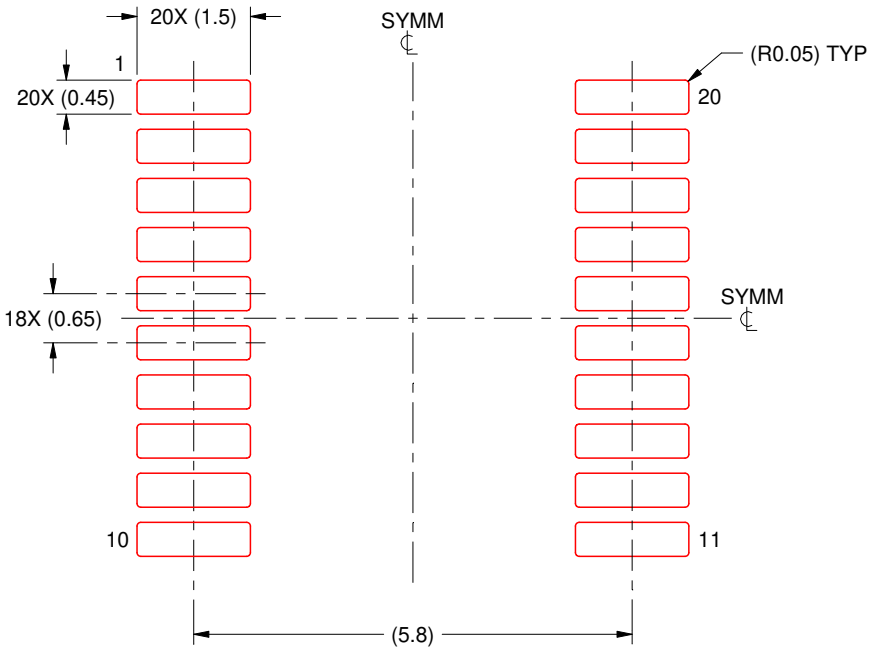


SOLDER MASK DETAILS

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NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE: 10X

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NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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